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6.776

High Speed Communication Circuits
Lecture 22

Noise in Integer-N and Fractional-N Frequency
Synthesizers

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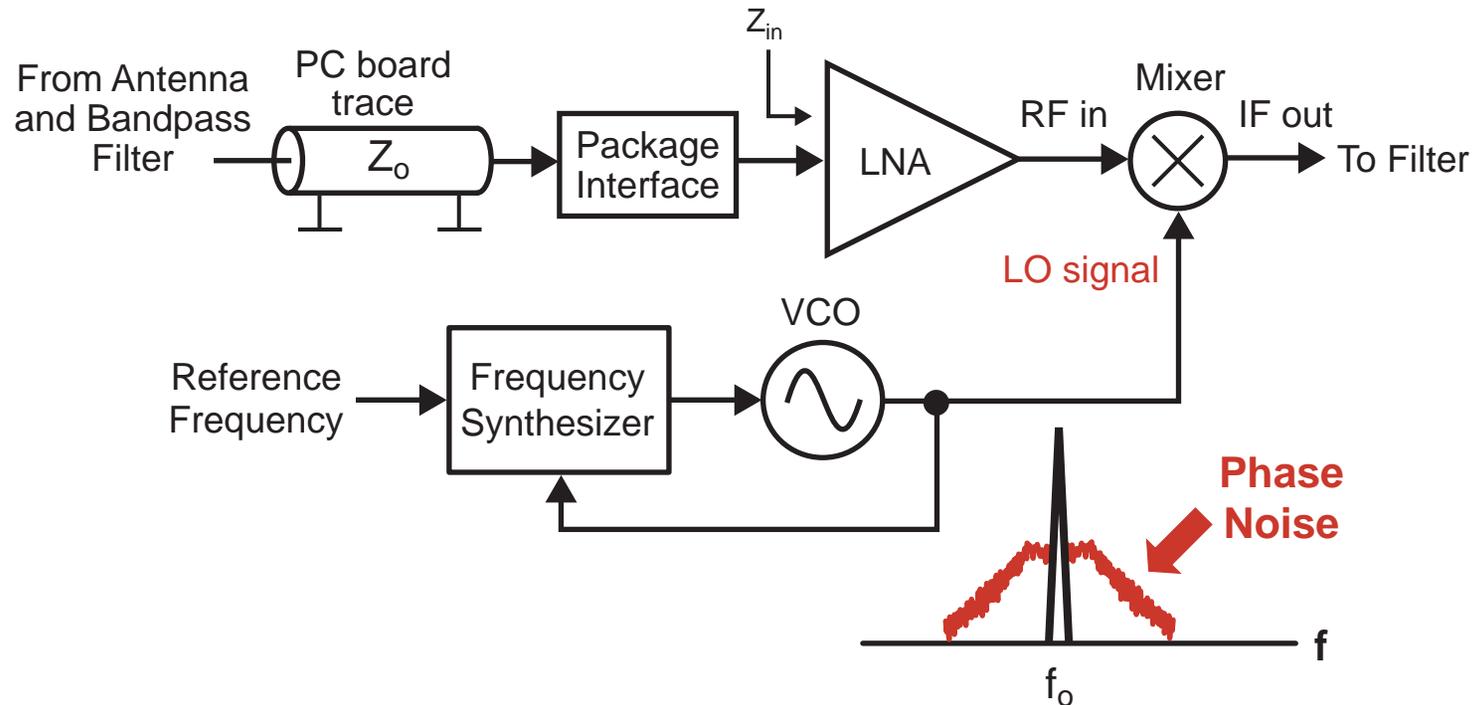
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Outline of PLL Lectures

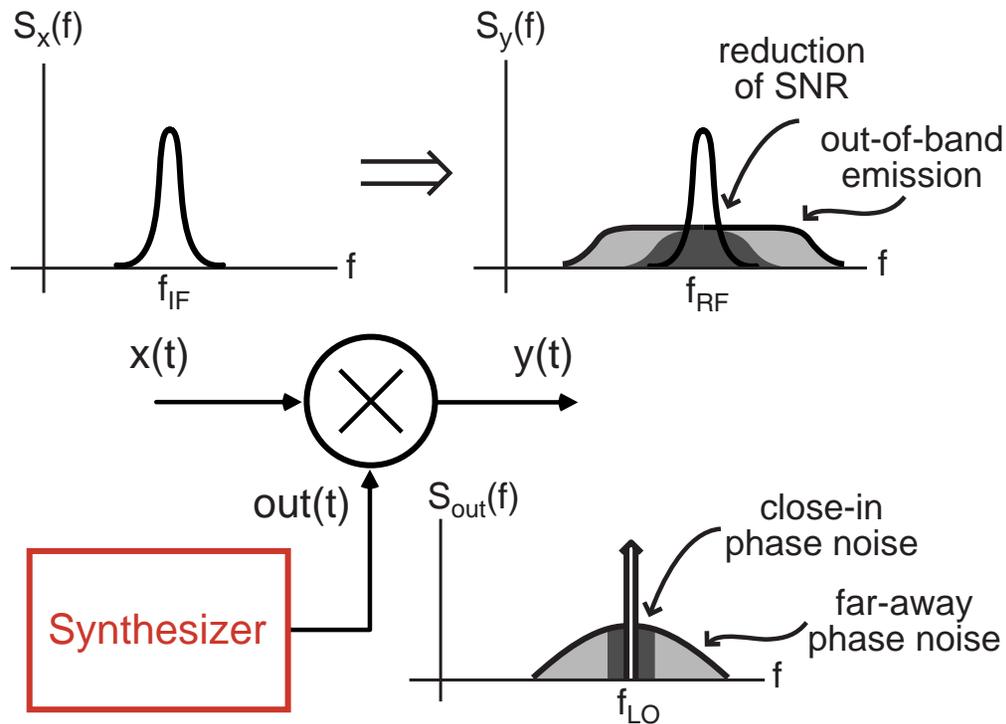
- **Integer-N Synthesizers**
 - Basic blocks, modeling, and design
 - Frequency detection, PLL Type
- **Noise in Integer-N and Fractional-N Synthesizers**
 - Noise analysis of integer-N structure
 - Sigma-Delta modulators applied to fractional-N structures
 - Noise analysis of fractional-N structure
- **Design of Fractional-N Frequency Synthesizers and Bandwidth Extension Techniques**
 - PLL Design Assistant Software
 - Quantization noise reduction for improved bandwidth and noise

Frequency Synthesizer Noise in Wireless Systems



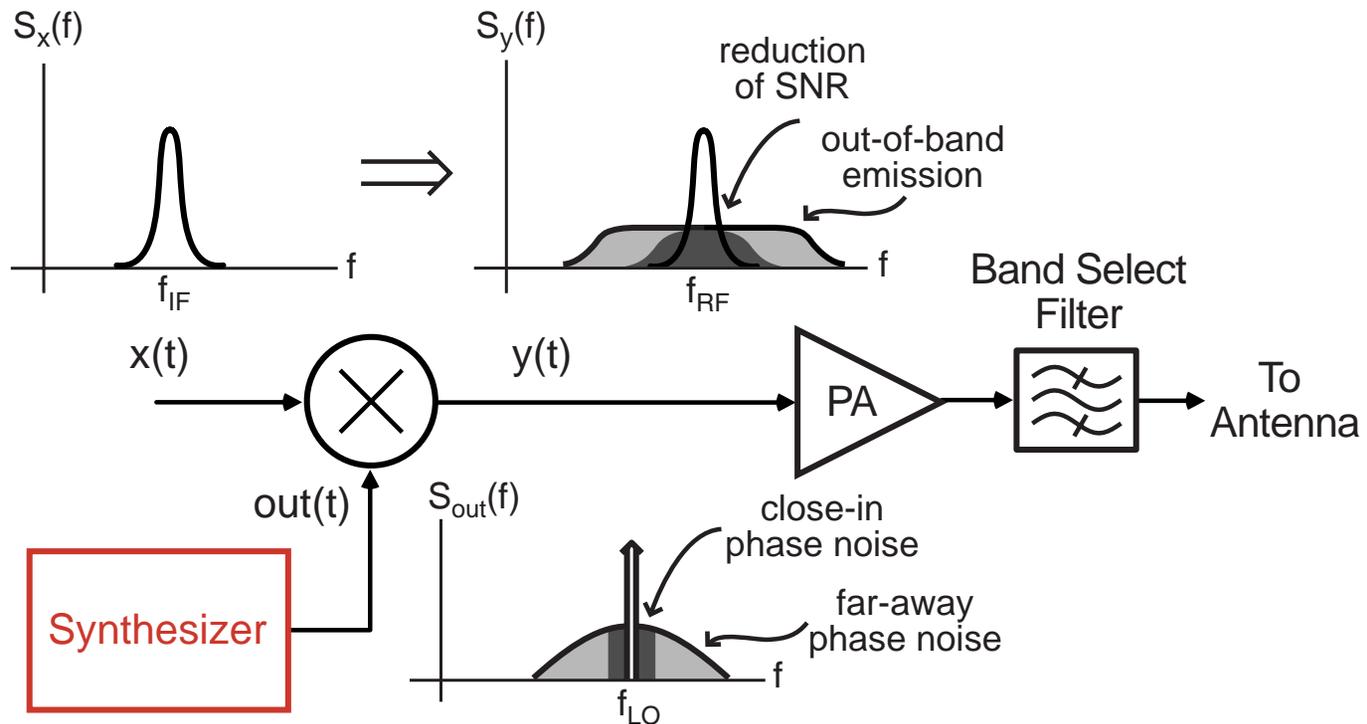
- **Synthesizer noise has a negative impact on system**
 - Receiver – lower sensitivity, poorer blocking performance
 - Transmitter – increased spectral emissions (output spectrum must meet a mask requirement)
- **Noise is characterized in frequency domain**

Impact of Synthesizer Noise on Transmitters



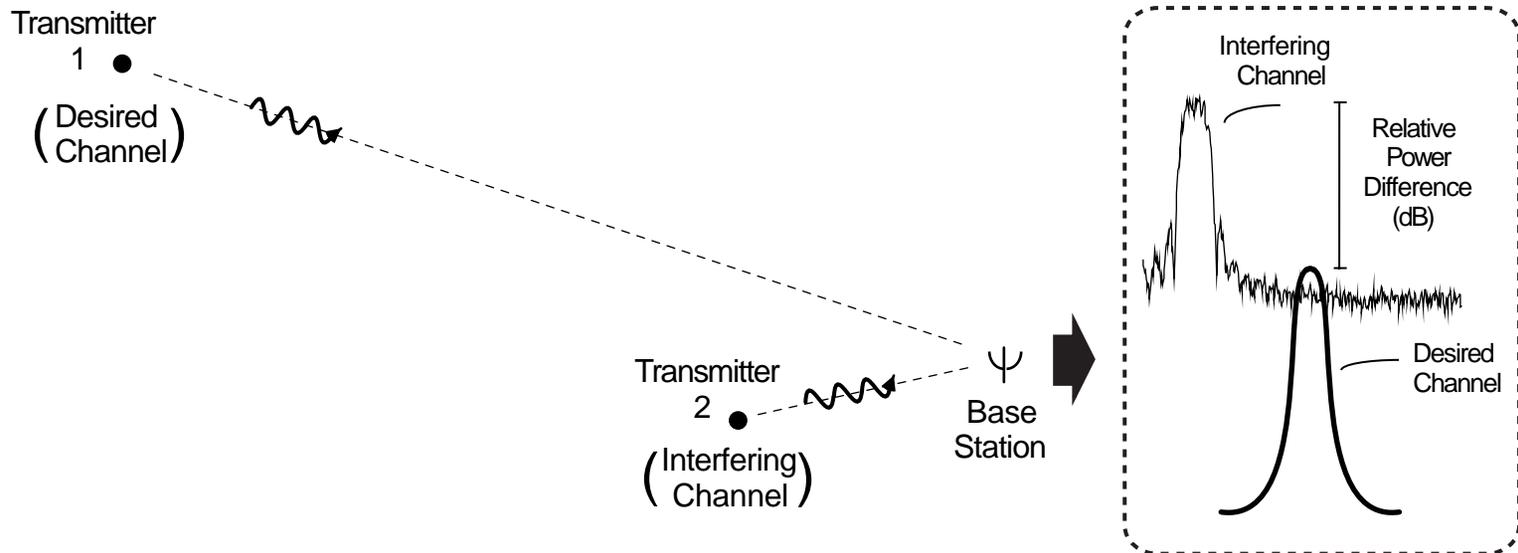
- **Synthesizer noise can be lumped into two categories**
 - **Close-in phase noise: reduces SNR of modulated signal**
 - **Far-away phase noise: creates spectral emissions outside the desired transmit channel**
 - This is the critical issue for transmitters

Impact of Remaining Portion of Transmitter



- **Power amplifier**
 - Nonlinearity will increase out-of-band emission and create harmonic content
- **Band select filter**
 - Removes harmonic content, but not out-of-band emission

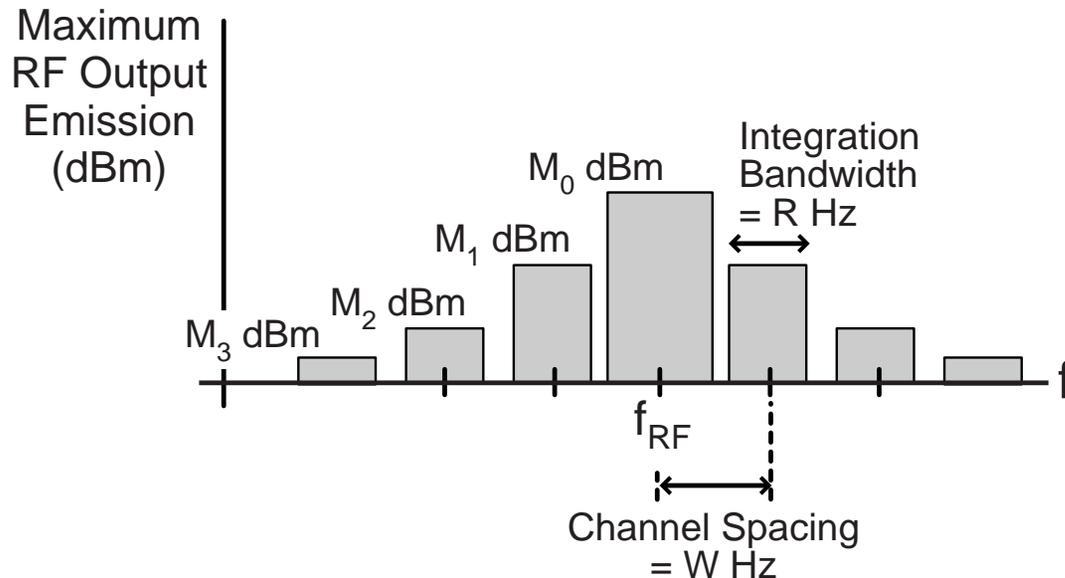
Why is Out-of-Band Emission A Problem?



■ Near-far problem

- Interfering transmitter closer to receiver than desired transmitter
- Out-of-emission requirements must be stringent to prevent complete corruption of desired signal

Specification of Out-of-Band Emissions



- **Maximum radiated power is specified in desired and adjacent channels**
 - **Desired channel power:** maximum is M_0 dBm
 - **Out-of-band emission:** maximum power defined as integration of transmitted spectral density over bandwidth R centered at midpoint of each channel offset

Example – DECT Cordless Telephone Standard

- Standard for many cordless phones operating at 1.8 GHz
- Transmitter Specifications
 - Channel spacing: $W = 1.728$ MHz
 - Maximum output power: $M_0 = 250$ mW (24 dBm)
 - Integration bandwidth: $R = 1$ MHz
 - Emission mask requirements

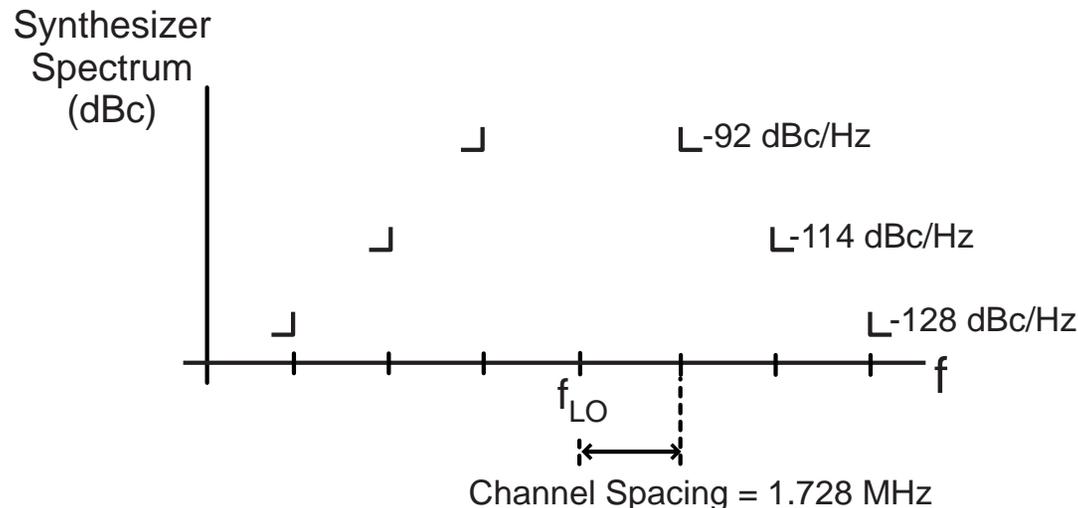
f_{offset} (MHz)	Emission Mask (dBm)
0	$M_0 = 24$ dBm
1.728	$M_1 = -8$ dBm
3.456	$M_2 = -30$ dBm
5.184	$M_3 = -44$ dBm

Synthesizer Phase Noise Requirements for DECT

- Calculations (see Lecture 16 of MIT OCW 6.976 for details)

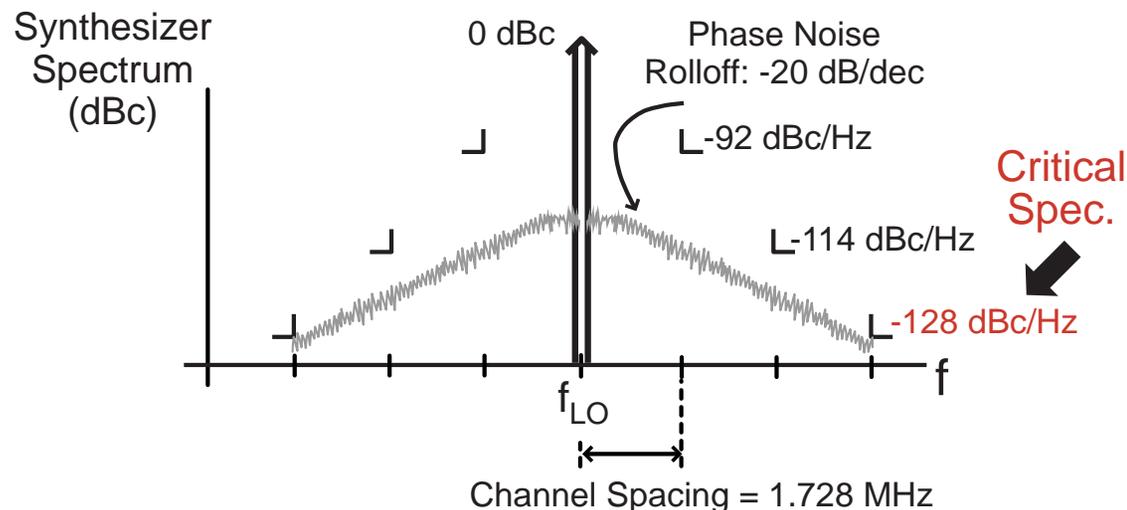
Channel Offset	Mask Power	Maximum Synth. Noise Power in Integration BW	Maximum Synth. Phase Noise at Channel Offset
0	24 dBm	set by required transmit SNR	
1.728 MHz	-8 dBm	$X_1 = -29.6$ dBc	-92 dBc/Hz
3.456 MHz	-30 dBm	$X_2 = -51.6$ dBc	-114 dBc/Hz
5.184 MHz	-44 dBm	$X_3 = -65.6$ dBc	-128 dBc/Hz

- Graphical display of phase noise mask

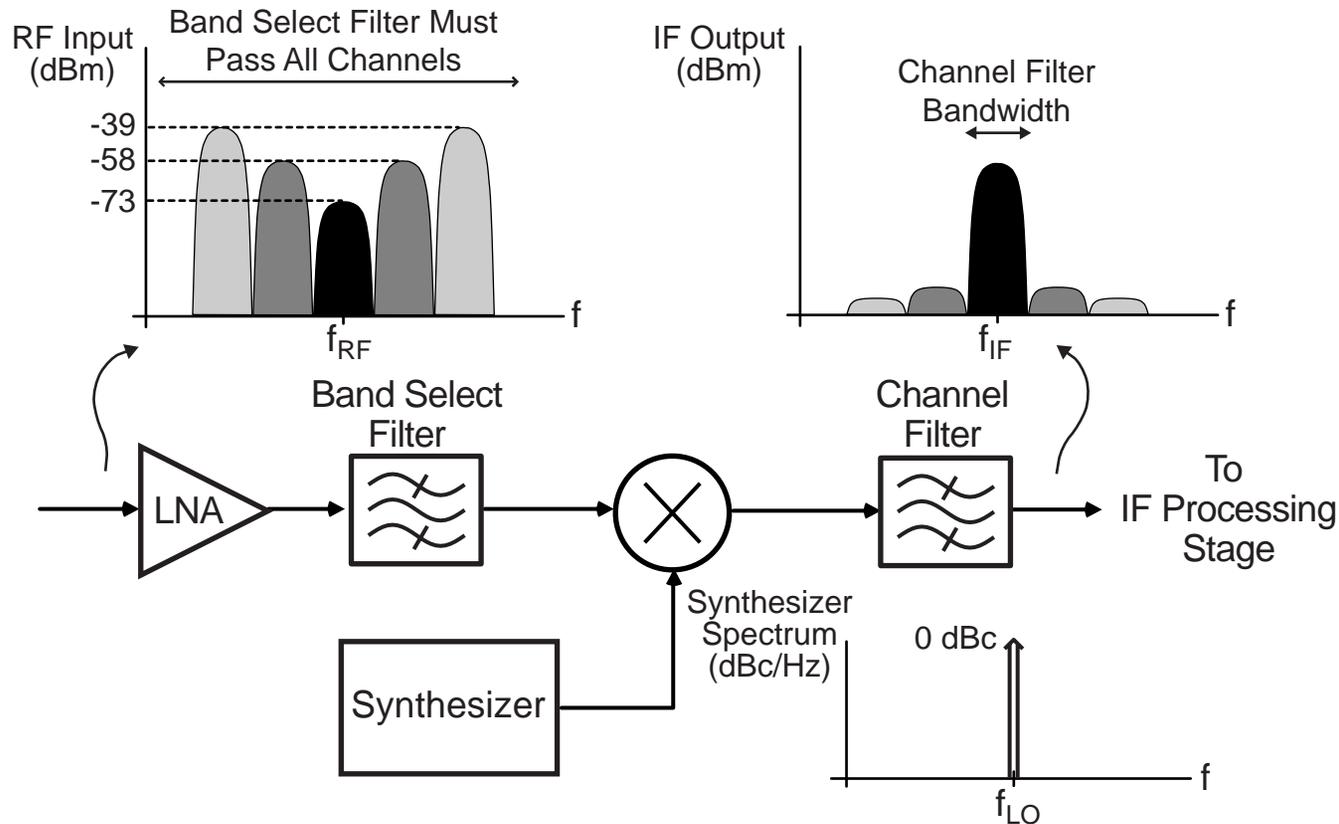


Critical Specification for Phase Noise

- Critical specification is defined to be the one that is hardest to meet with an assumed phase noise rolloff
 - Assume synthesizer phase noise rolls off at -20 dB/decade
 - Corresponds to VCO phase noise characteristic
- For DECT transmitter synthesizer
 - Critical specification is -128 dBc/Hz at 5.184 MHz offset

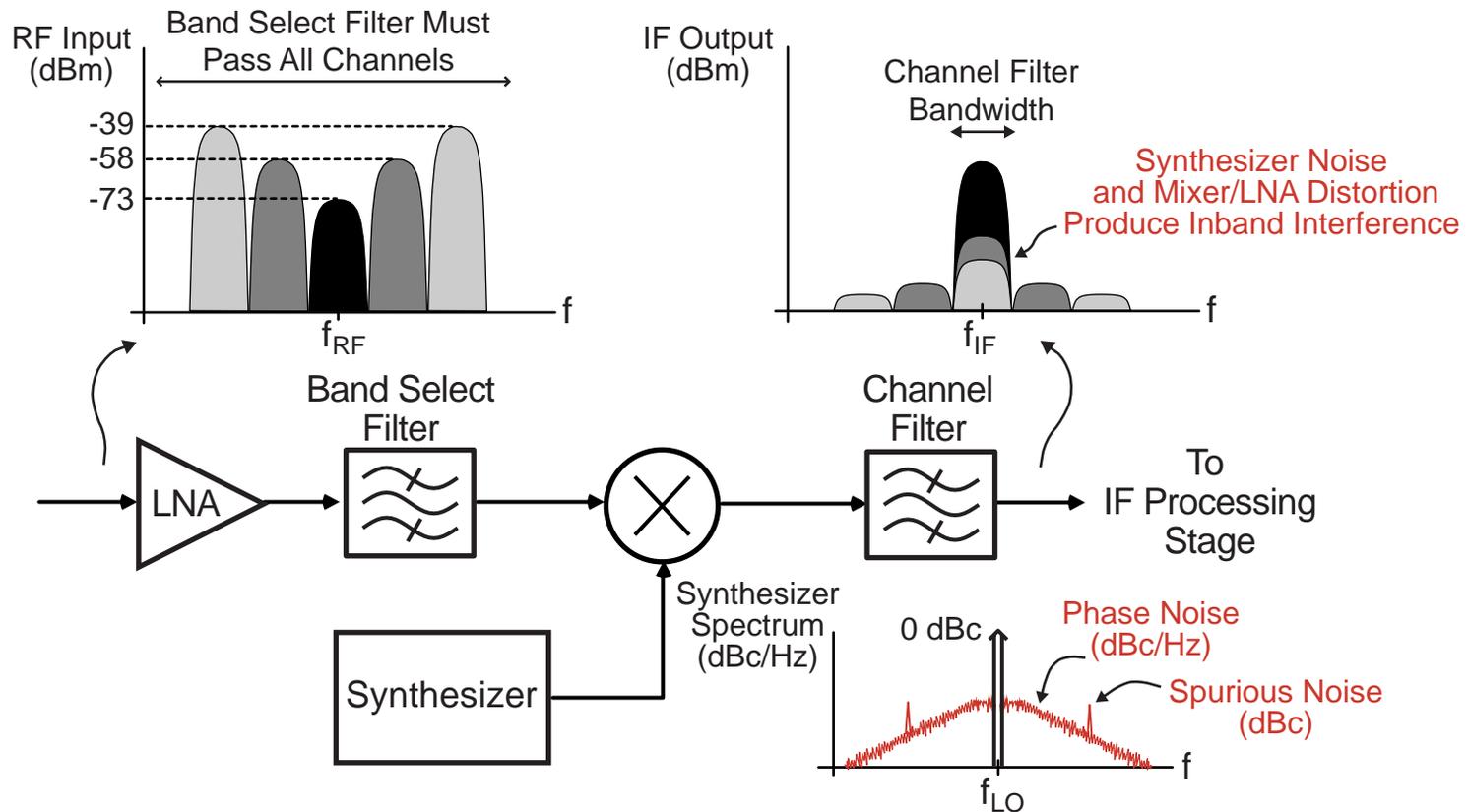


Receiver Blocking Performance



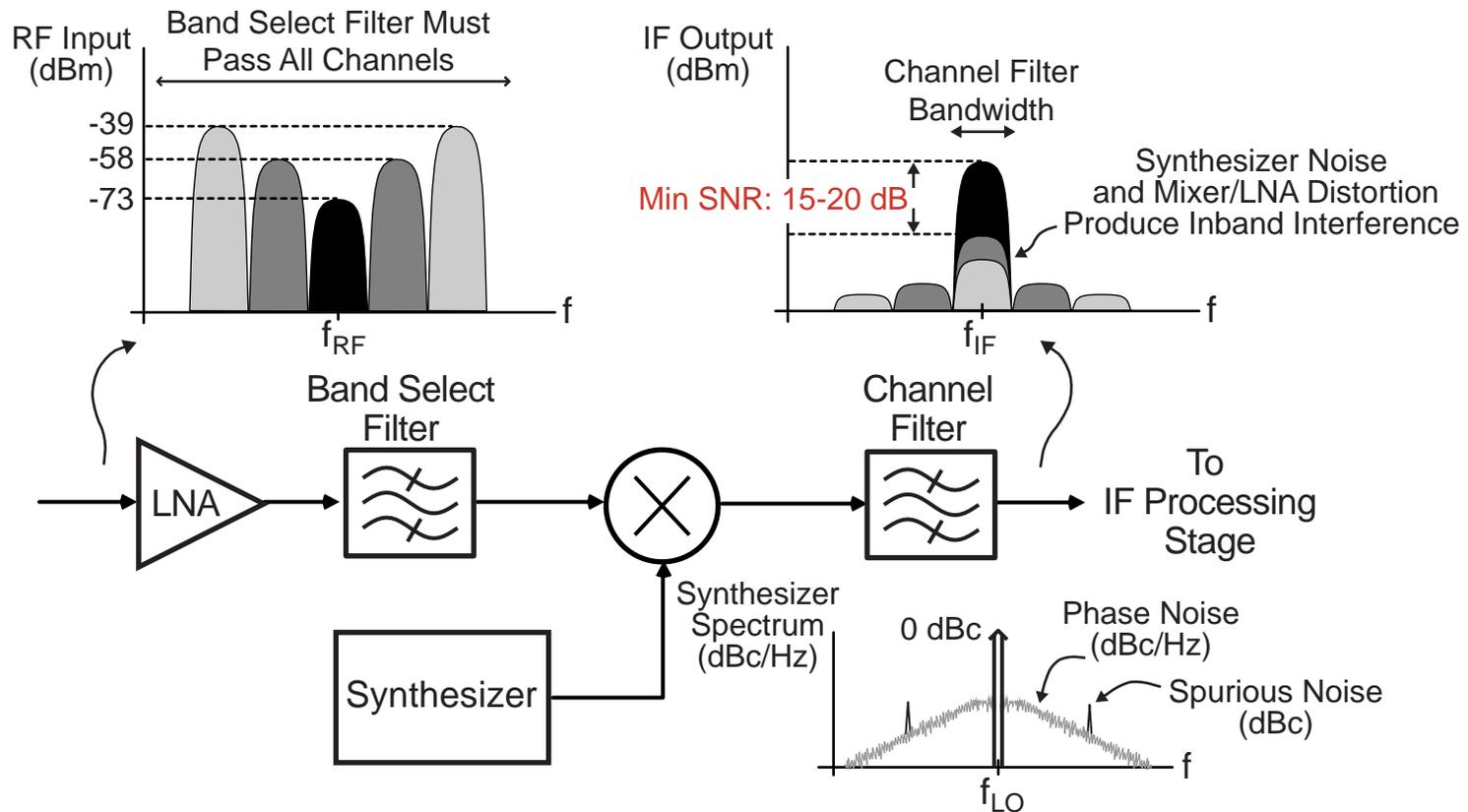
- Radio receivers must operate in the presence of large interferers (called blockers)
- Channel filter plays critical role in removing blockers
 - Passes desired signal channel, rejects interferers

Impact of Nonidealities on Blocking Performance



- **Blockers leak into desired band due to**
 - Nonlinearity of LNA and mixer (IIP3)
 - Synthesizer phase and spurious noise
- **In-band interference cannot be removed by channel filter!**

Quantifying Tolerable In-Band Interference Levels



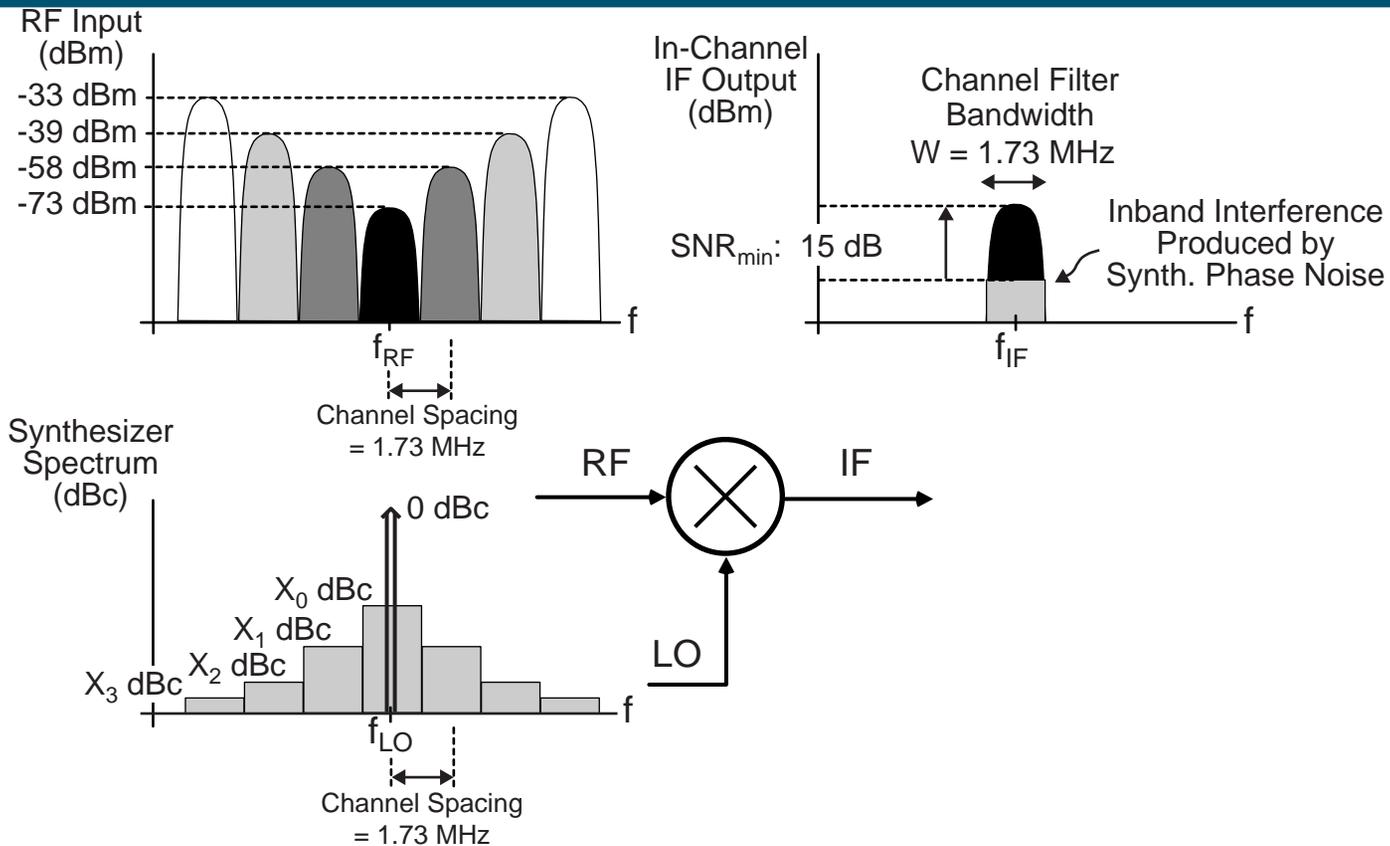
- **Digital radios quantify performance with bit error rate (BER)**
 - Minimum BER often set at $1e-3$ for many radio systems
 - There is a corresponding minimum SNR that must be achieved
- **Goal: design so that SNR with interferers is above SNR_{min}**

Example – DECT Cordless Telephone Standard

- Receiver blocking specifications
 - Channel spacing: $W = 1.728$ MHz
 - Power of desired signal for blocking test: -73 dBm
 - Minimum bit error rate (BER) with blockers: $1e-3$
 - Sets the value of SNR_{min}
 - Perform receiver simulations to determine SNR_{min}
 - Assume $SNR_{min} = 15$ dB for calculations to follow
 - Strength of interferers for blocking test

f_{offset} (MHz)	Blocker Power (dBm)	Relative Strength
1.728	-58 dBm	$Y_1 = 15$ dB
3.456	-39 dBm	$Y_2 = 34$ dB
5.184	-33 dBm	$Y_3 = 40$ dB

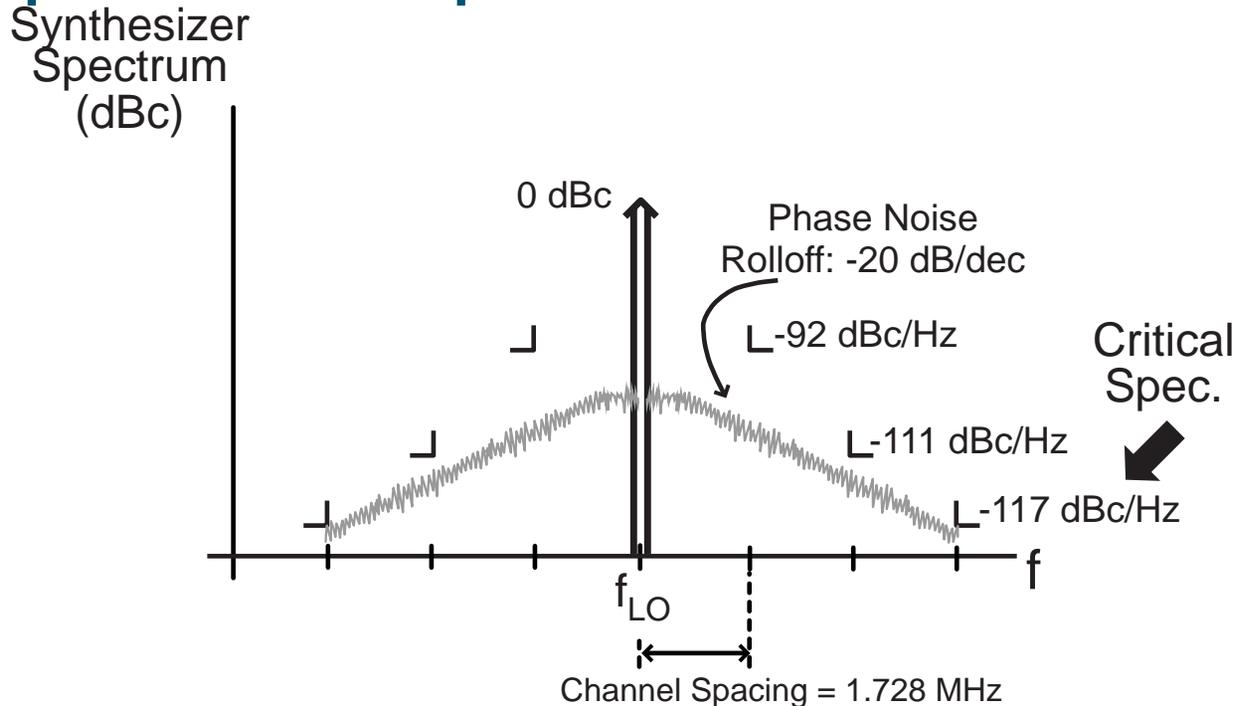
Synthesizer Phase Noise Requirements for DECT



Channel Offset	Relative Blocking Power	Maximum Synth. Noise Power at Channel Offset	Maximum Synth. Phase Noise at Channel Offset
0	0 dB	$X_0 = -15$ dBc	-77 dBc/Hz
1.728 MHz	$Y_1 = 15$ dB	$X_1 = -30$ dBc	-92 dBc/Hz
3.456 MHz	$Y_2 = 34$ dB	$X_2 = -49$ dBc	-111 dBc/Hz
5.184 MHz	$Y_3 = 40$ dB	$X_3 = -55$ dBc	-117 dBc/Hz

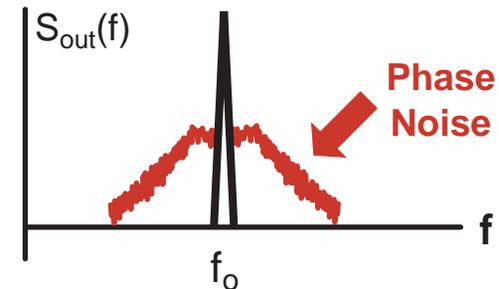
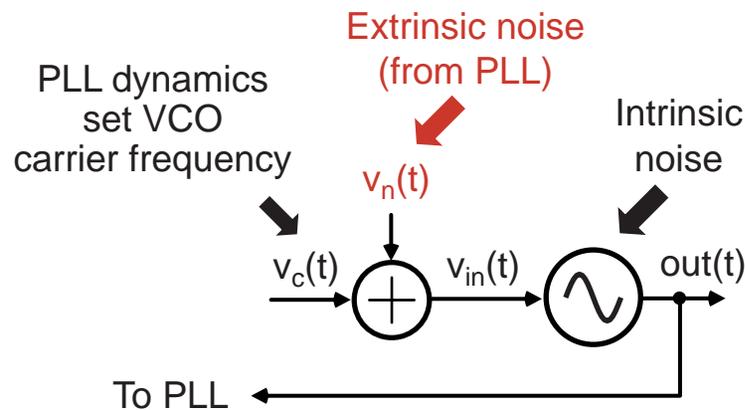
Graphical Display of Required Phase Noise Performance

- Mark phase noise requirements at each offset frequency



- Calculate critical specification for receive synthesizer
 - Critical specification is -117 dBc/Hz at 5.184 MHz offset
 - Lower performance demanded of receiver synthesizer than transmitter synthesizer in DECT applications!

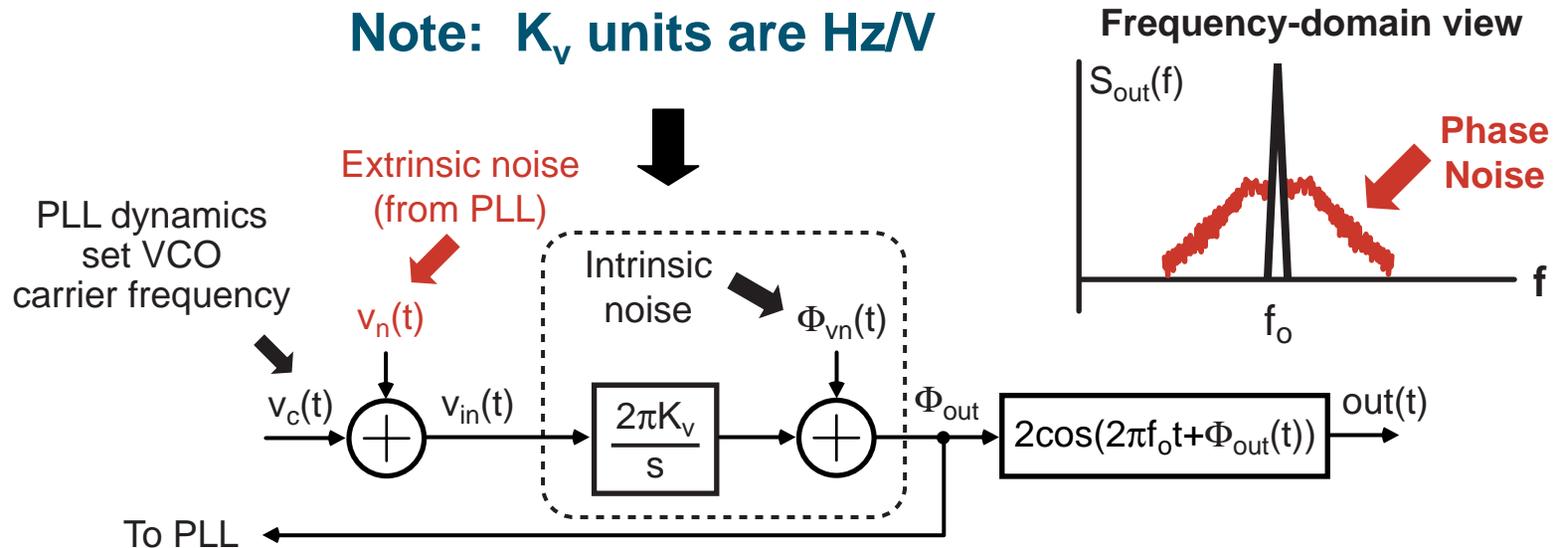
Noise Modeling for Frequency Synthesizers



- **PLL has an impact on VCO noise in two ways**
 - Adds noise from various PLL circuits
 - Suppresses low frequency VCO noise through PLL feedback
- **Focus on modeling the above based on phase deviations**
 - Simpler than dealing directly with PLL sine wave output

Phase Deviation Model for Noise Analysis

Note: K_v units are Hz/V



- Model the impact of noise on instantaneous phase
 - Relationship between PLL output and instantaneous phase

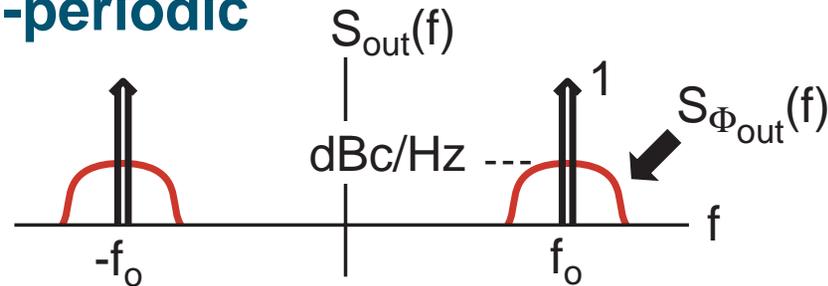
$$out(t) = 2 \cos(2\pi f_o t + \underline{\Phi_{out}(t)})$$

- Output spectrum

$$S_{out}(f) = S_{sin}(f) + S_{sin}(f) * S_{\Phi_{out}}$$

Phase Noise Versus Spurious Noise

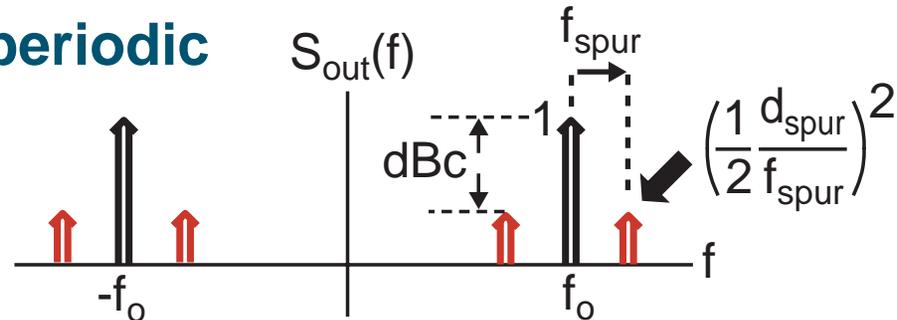
- Phase noise is non-periodic



- Described as a spectral density relative to carrier power

$$L(f) = 10 \log(S_{\Phi_{out}}(f)) \text{ dBc/Hz}$$

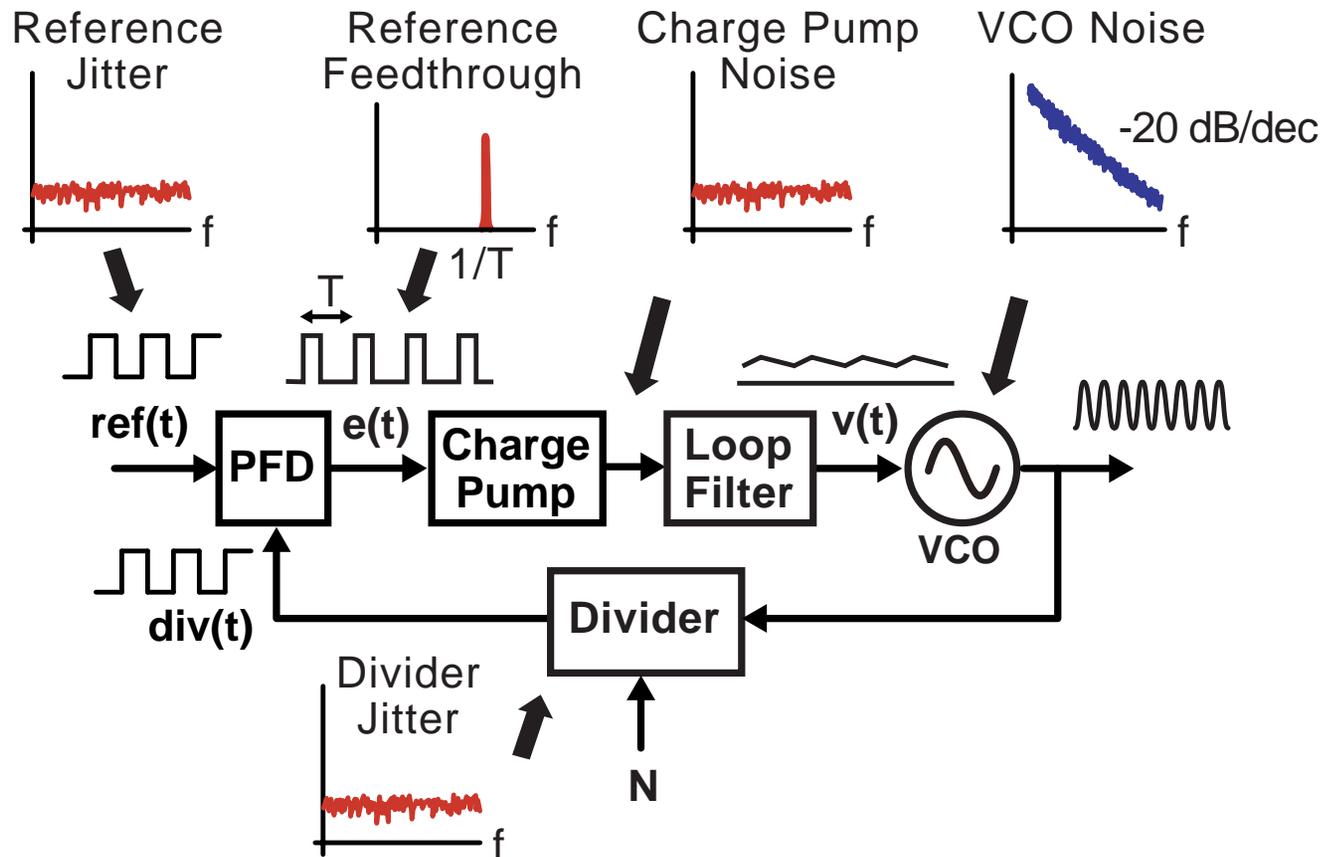
- Spurious noise is periodic



- Described as tone power relative to carrier power

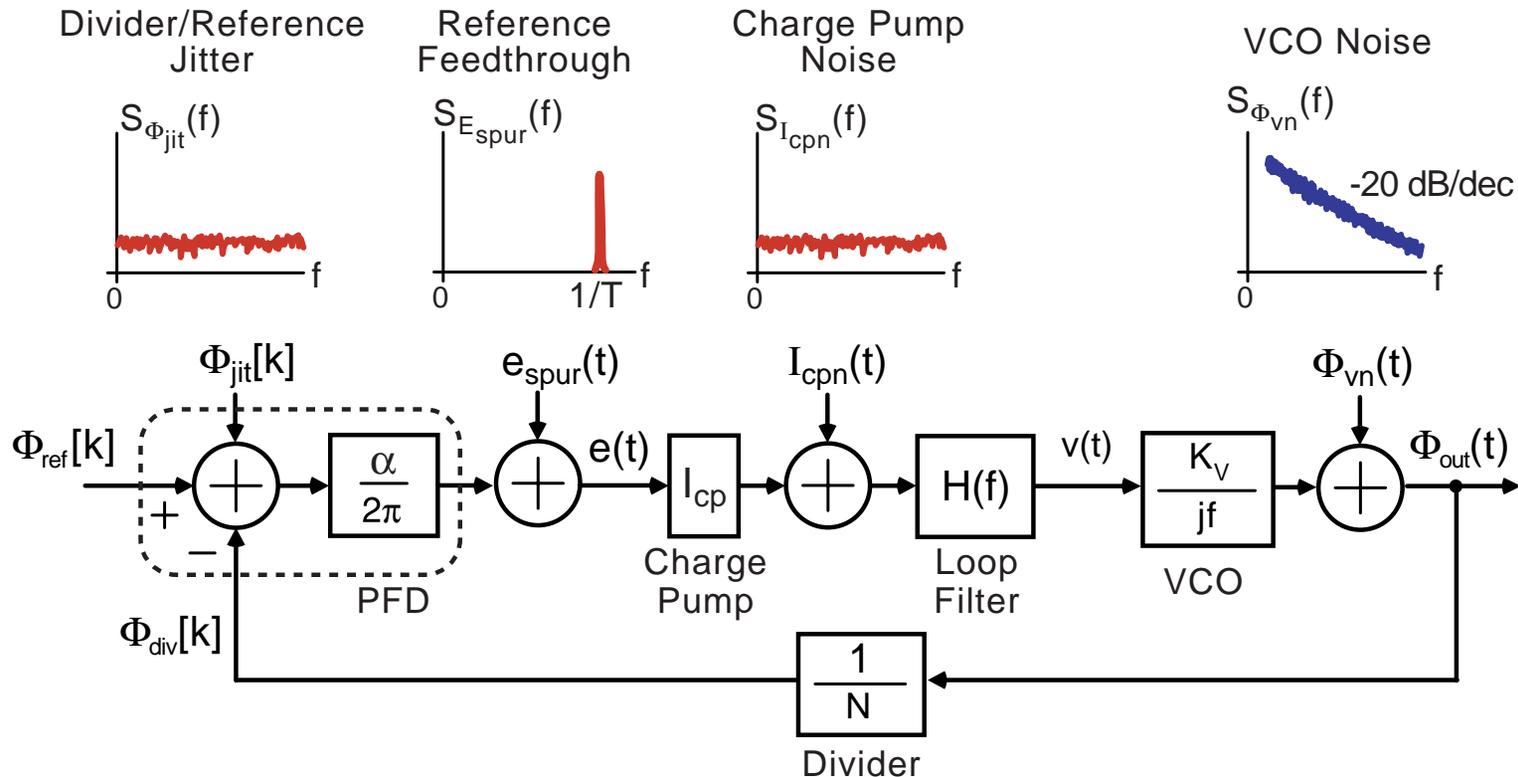
$$20 \log \left(\frac{d_{spur}}{2f_{spur}} \right) \text{ dBc}$$

Sources of Noise in Frequency Synthesizers



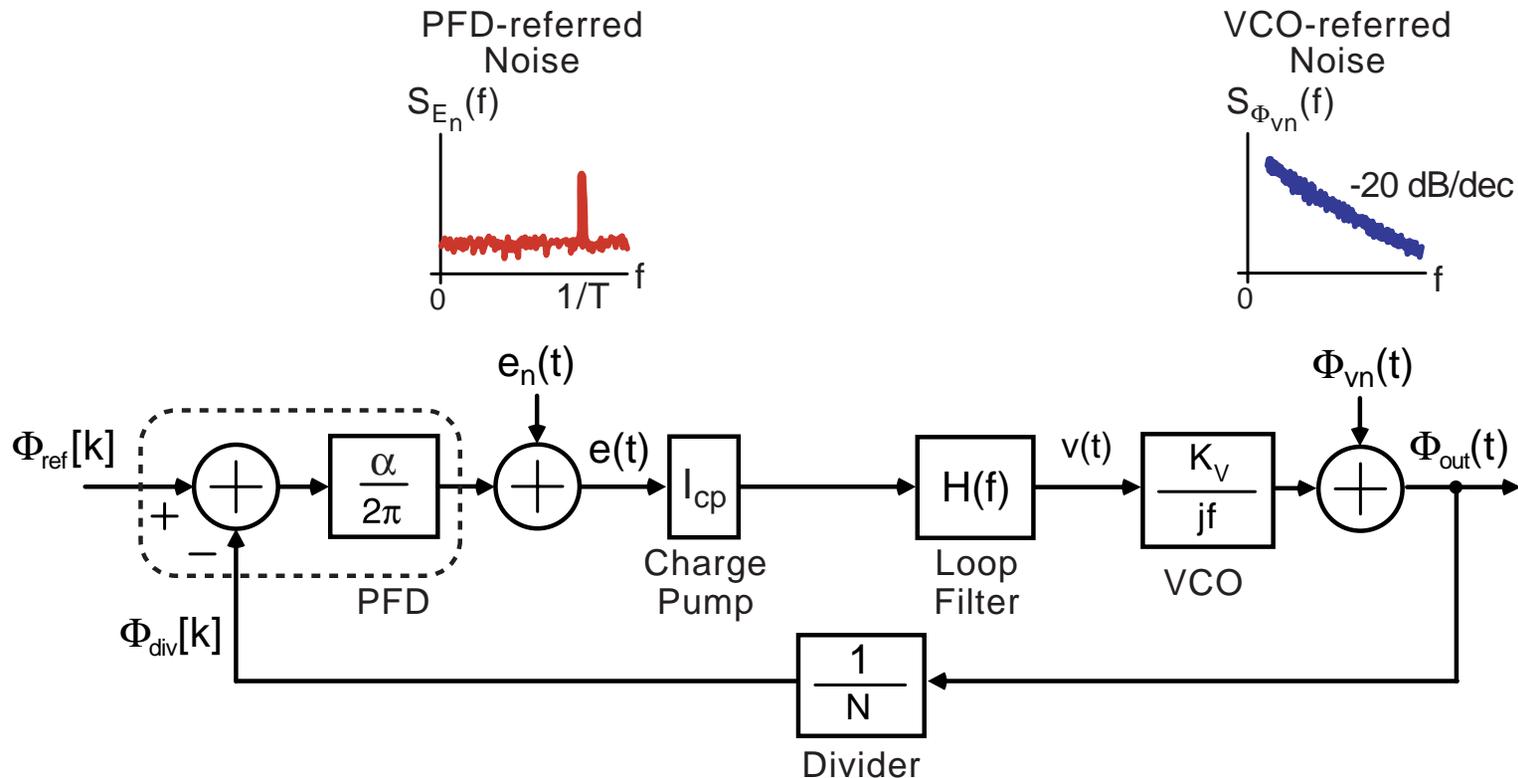
- **Extrinsic noise sources to VCO**
 - Reference/divider jitter and reference feedthrough
 - Charge pump noise

Modeling the Impact of Noise on Output Phase of PLL



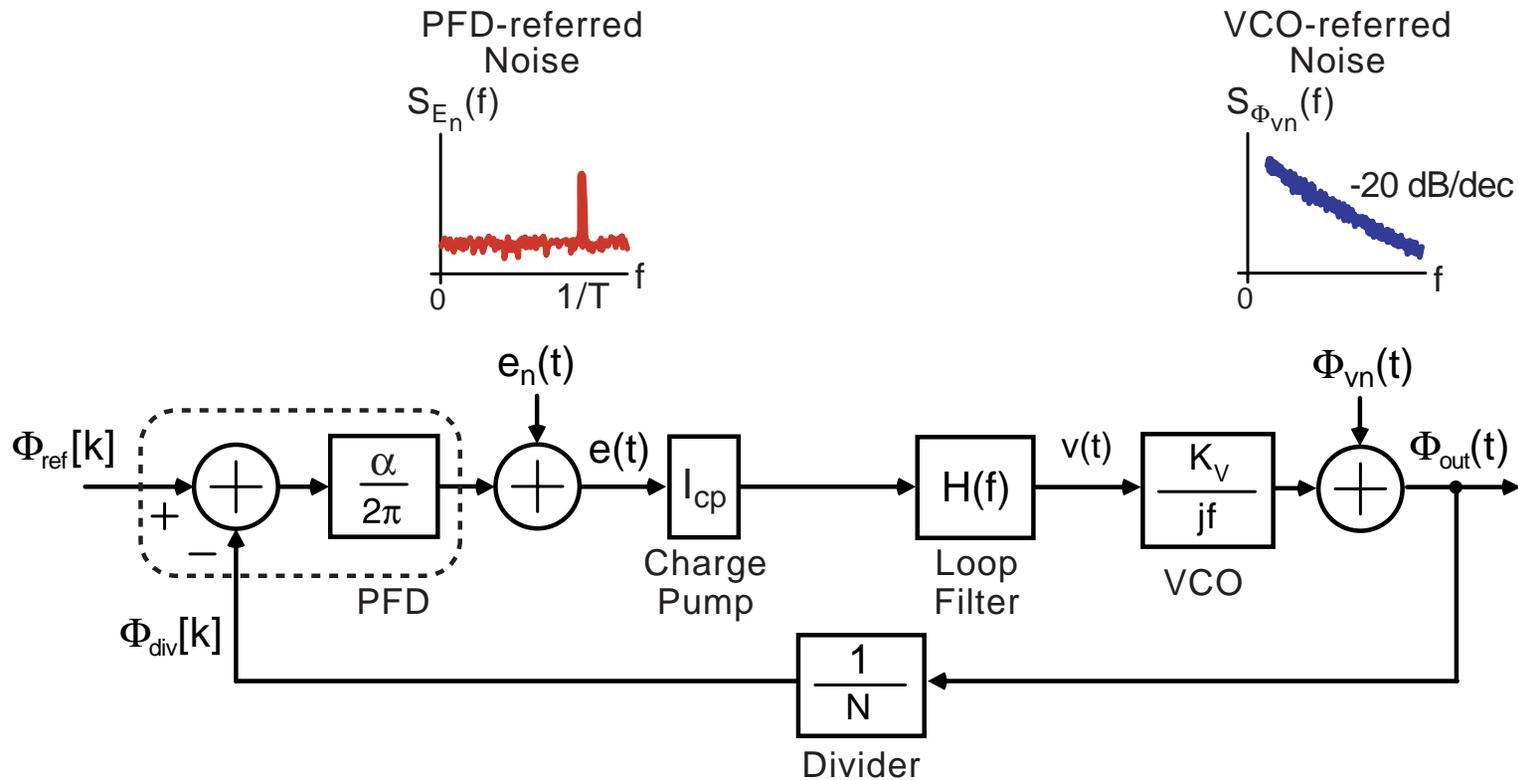
- Determine impact on output phase by deriving transfer function from each noise source to PLL output phase
 - There are a lot of transfer functions to keep track of!

Simplified Noise Model



- Refer all PLL noise sources (other than the VCO) to the PFD output
 - PFD-referred noise corresponds to the sum of these noise sources referred to the PFD output

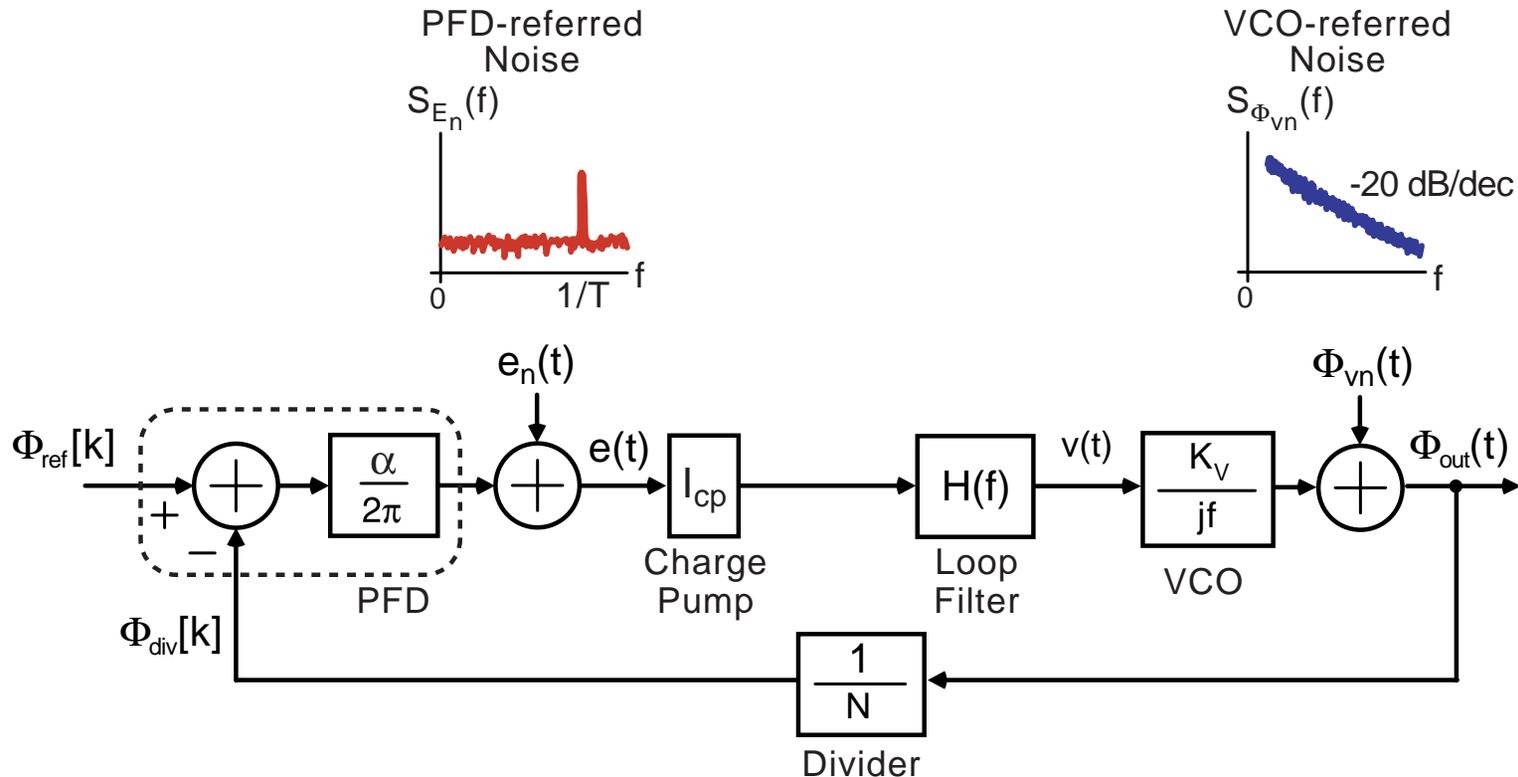
Impact of PFD-referred Noise on Synthesizer Output



- Transfer function derived using Black's formula

$$\frac{\Phi_{out}}{e_n} = \frac{I_{cp}H(f)K_v/(jf)}{1 + \alpha/(2\pi)I_{cp}H(f)K_v/(jf)(1/N)}$$

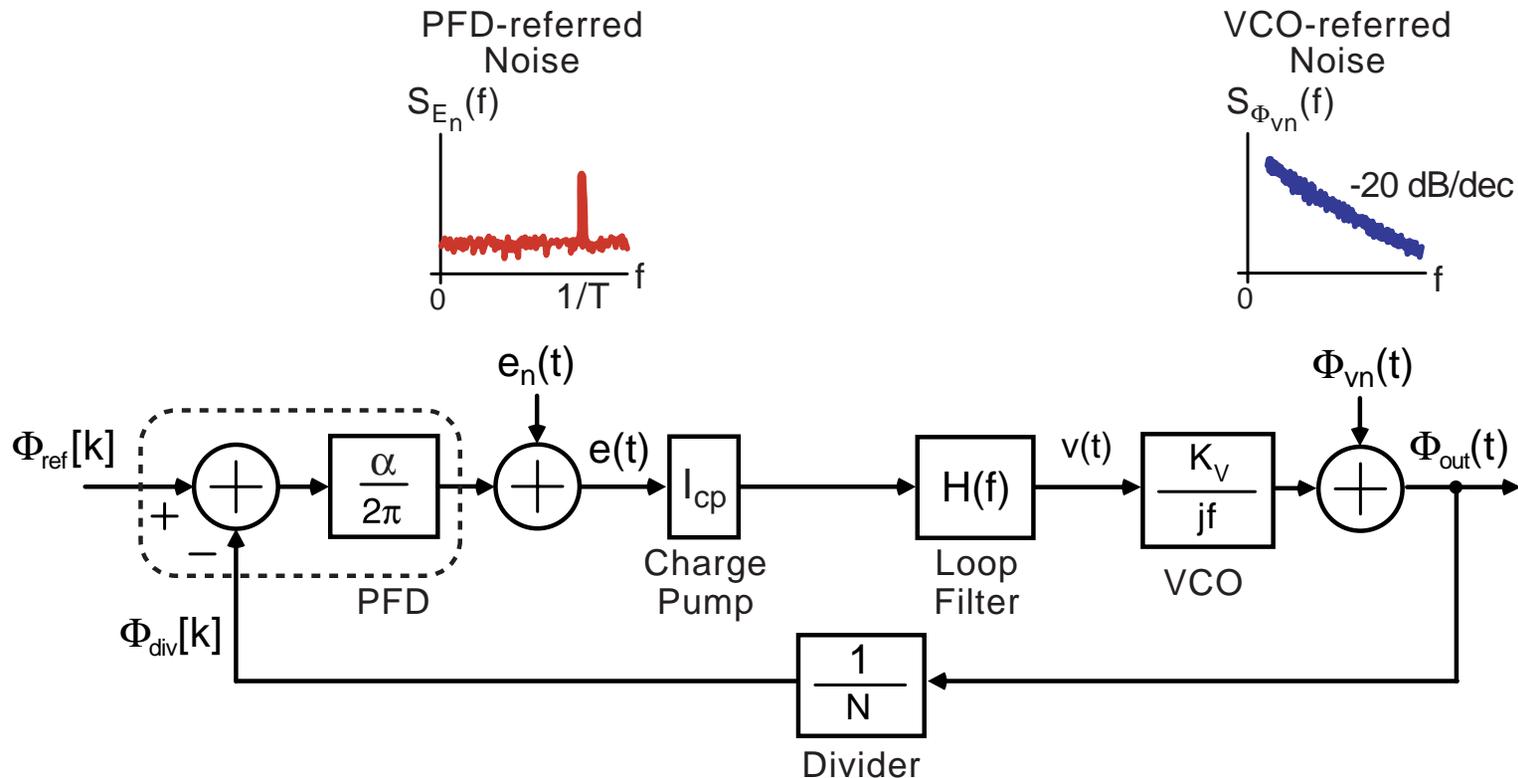
Impact of VCO-referred Noise on Synthesizer Output



- Transfer function again derived from Black's formula

$$\frac{\Phi_{out}}{e_n} = \frac{1}{1 + \alpha/(2\pi)I_{cp}H(f)K_v/(jf)(1/N)}$$

A Simpler Parameterization for PLL Transfer Functions



- Define $G(f)$ as

$$G(f) = \frac{A(f)}{1 + A(f)}$$

Always has a gain of one at DC

- $A(f)$ is the open loop transfer function of the PLL

$$A(f) = \alpha / (2\pi) I_{cp} H(f) K_v / (j f) (1/N)$$

Parameterize Noise Transfer Functions in Terms of $G(f)$

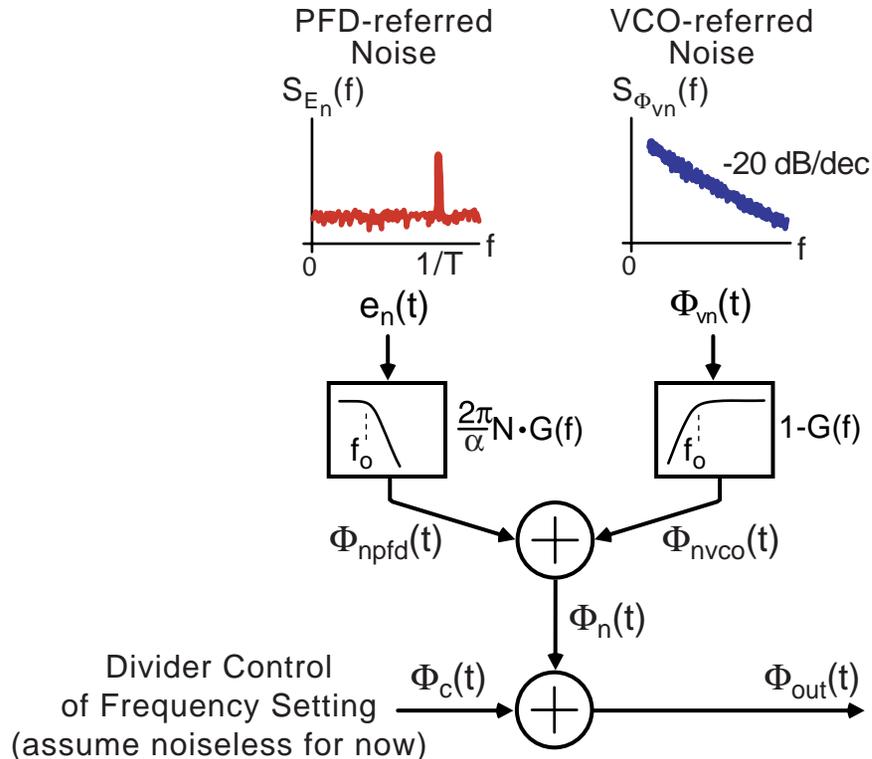
■ PFD-referred noise

$$\begin{aligned}\frac{\Phi_{out}}{e_n} &= \frac{I_{cp}H(f)K_v/(jf)}{1 + \alpha/(2\pi)I_{cp}H(f)K_v/(jf)(1/N)} \\ &= \frac{2\pi N}{\alpha} \frac{\alpha/(2\pi)I_{cp}H(f)K_v/(jf)(1/N)}{1 + \alpha/(2\pi)I_{cp}H(f)K_v/(jf)(1/N)} \\ &= \frac{2\pi N}{\alpha} \frac{A(f)}{1 + A(f)} = \boxed{\frac{2\pi N}{\alpha} G(f)}\end{aligned}$$

■ VCO-referred noise

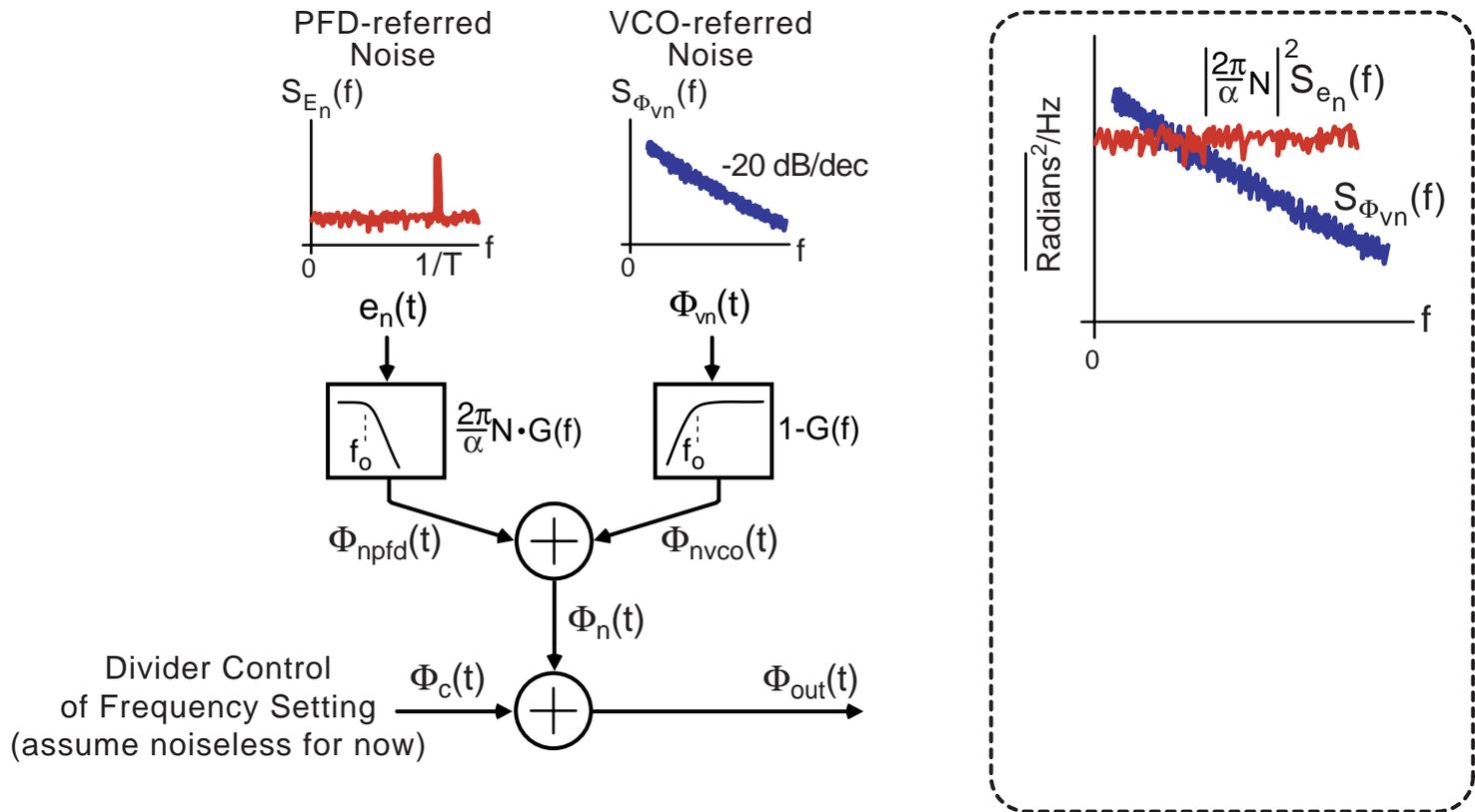
$$\begin{aligned}\frac{\Phi_{out}}{\Phi_{vn}} &= \frac{1}{1 + \alpha/(2\pi)I_{cp}H(f)K_v/(jf)(1/N)} \\ &= \frac{1}{1 + A(f)} = 1 - \frac{A(f)}{1 + A(f)} = \boxed{1 - G(f)}\end{aligned}$$

Parameterized PLL Noise Model



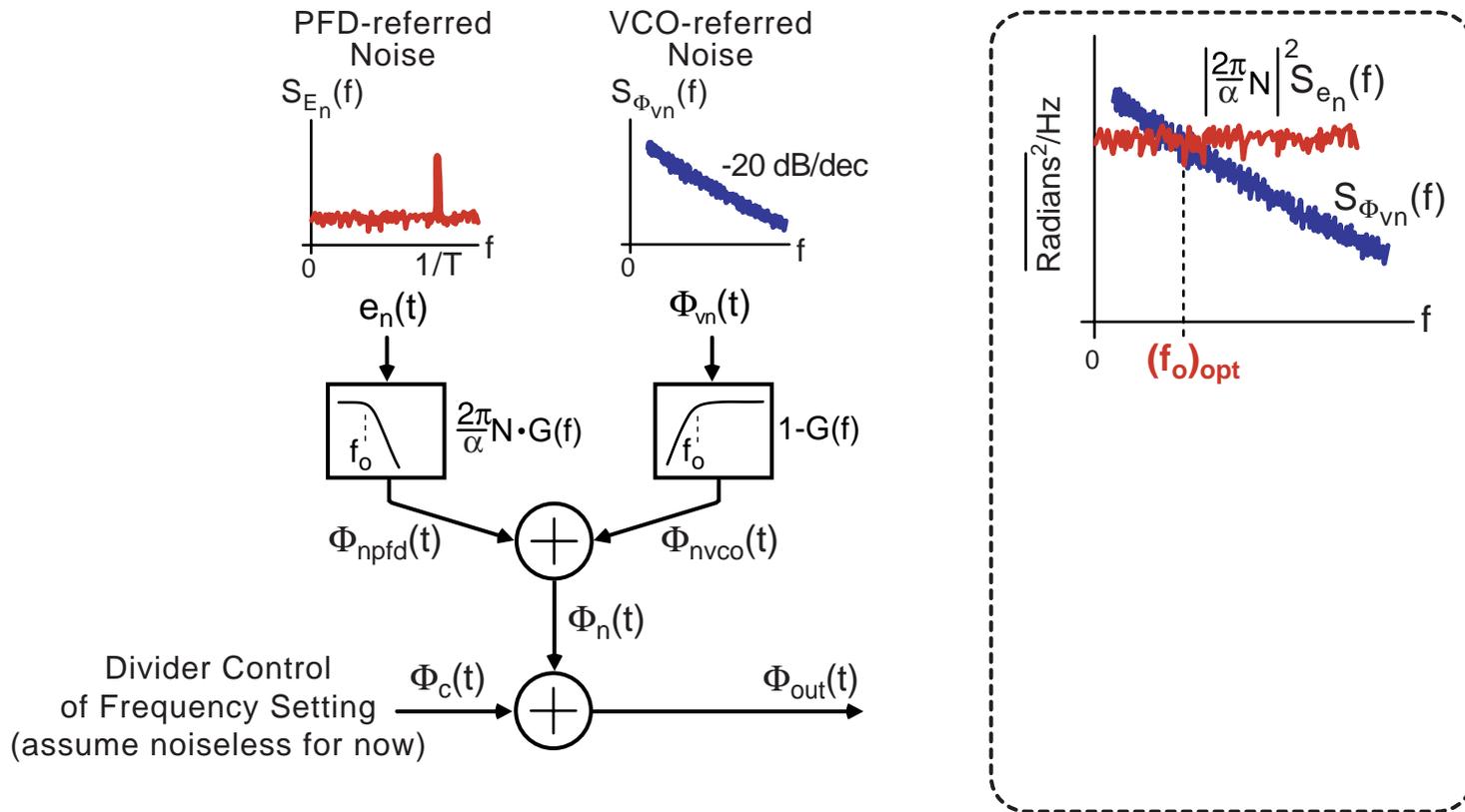
- PFD-referred noise is lowpass filtered
- VCO-referred noise is highpass filtered
- Both filters have the same transition frequency values
 - Defined as f_o

Impact of PLL Parameters on Noise Scaling



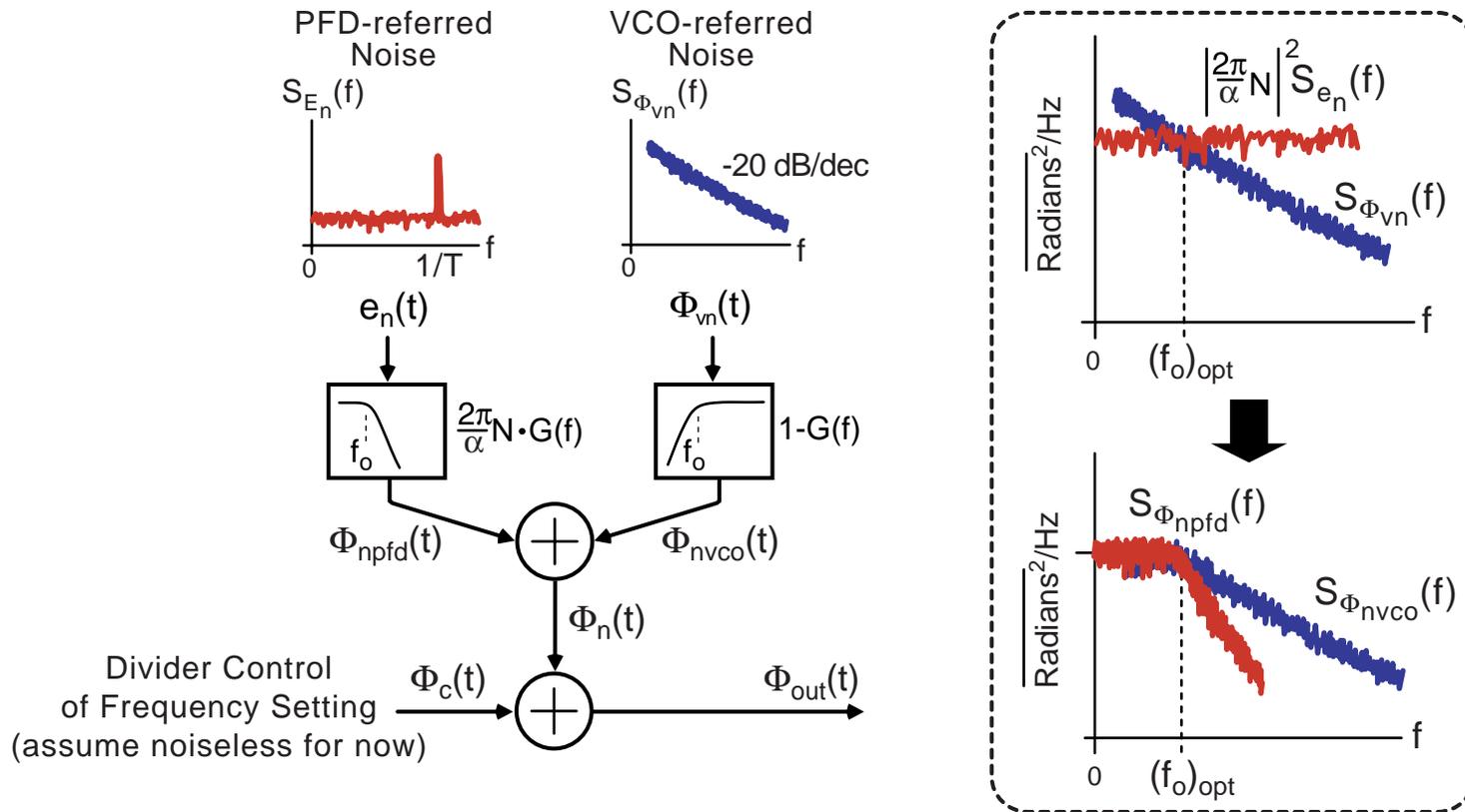
- **PFD-referred noise is scaled by square of divide value and inverse of PFD gain**
 - High divide values lead to large multiplication of this noise
- **VCO-referred noise is not scaled (only filtered)**

Optimal Bandwidth Setting for Minimum Noise



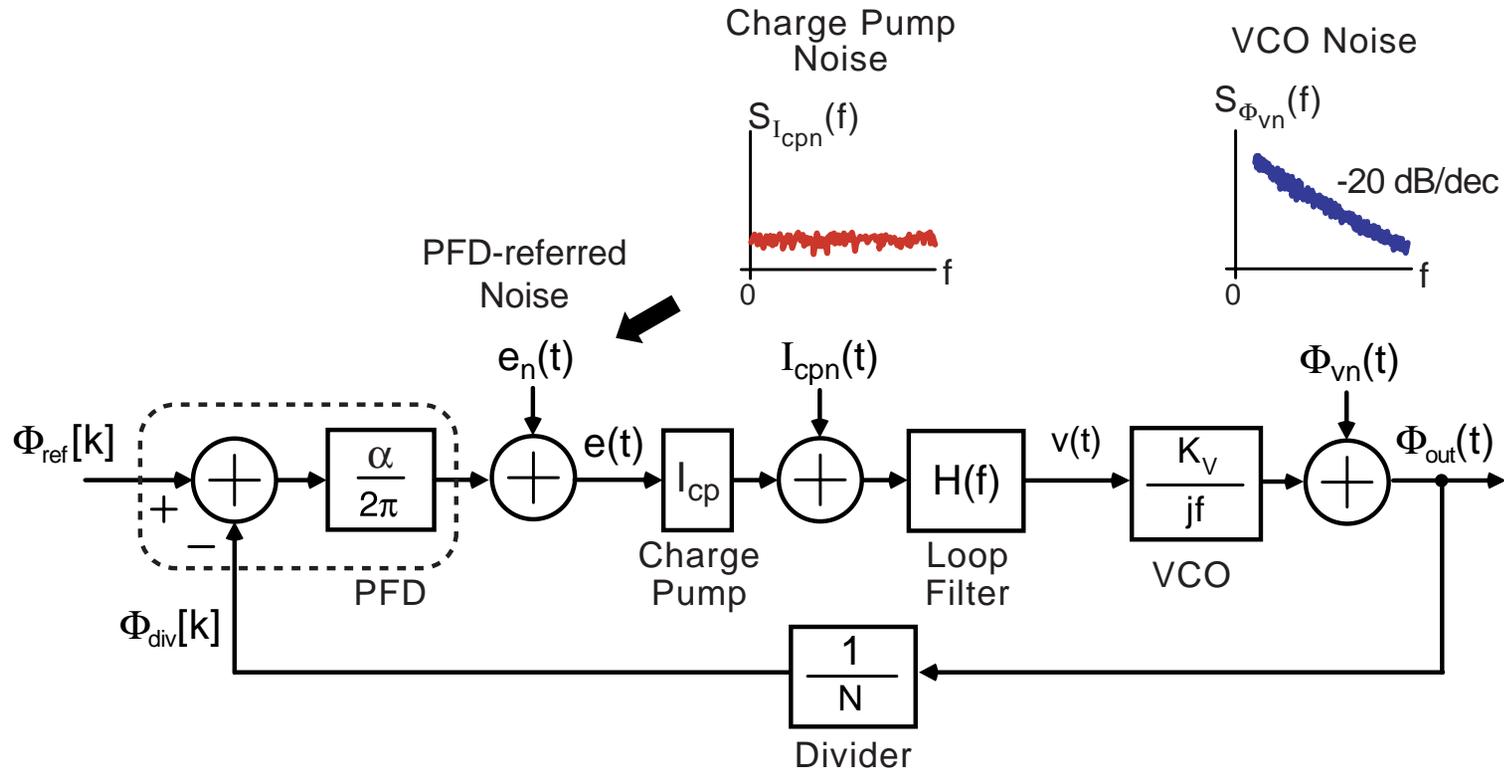
- **Optimal bandwidth is where scaled noise sources meet**
 - Higher bandwidth will pass more PFD-referred noise
 - Lower bandwidth will pass more VCO-referred noise

Resulting Output Noise with Optimal Bandwidth



- **PFD-referred noise dominates at low frequencies**
 - Corresponds to close-in phase noise of synthesizer
- **VCO-referred noise dominates at high frequencies**
 - Corresponds to far-away phase noise of synthesizer

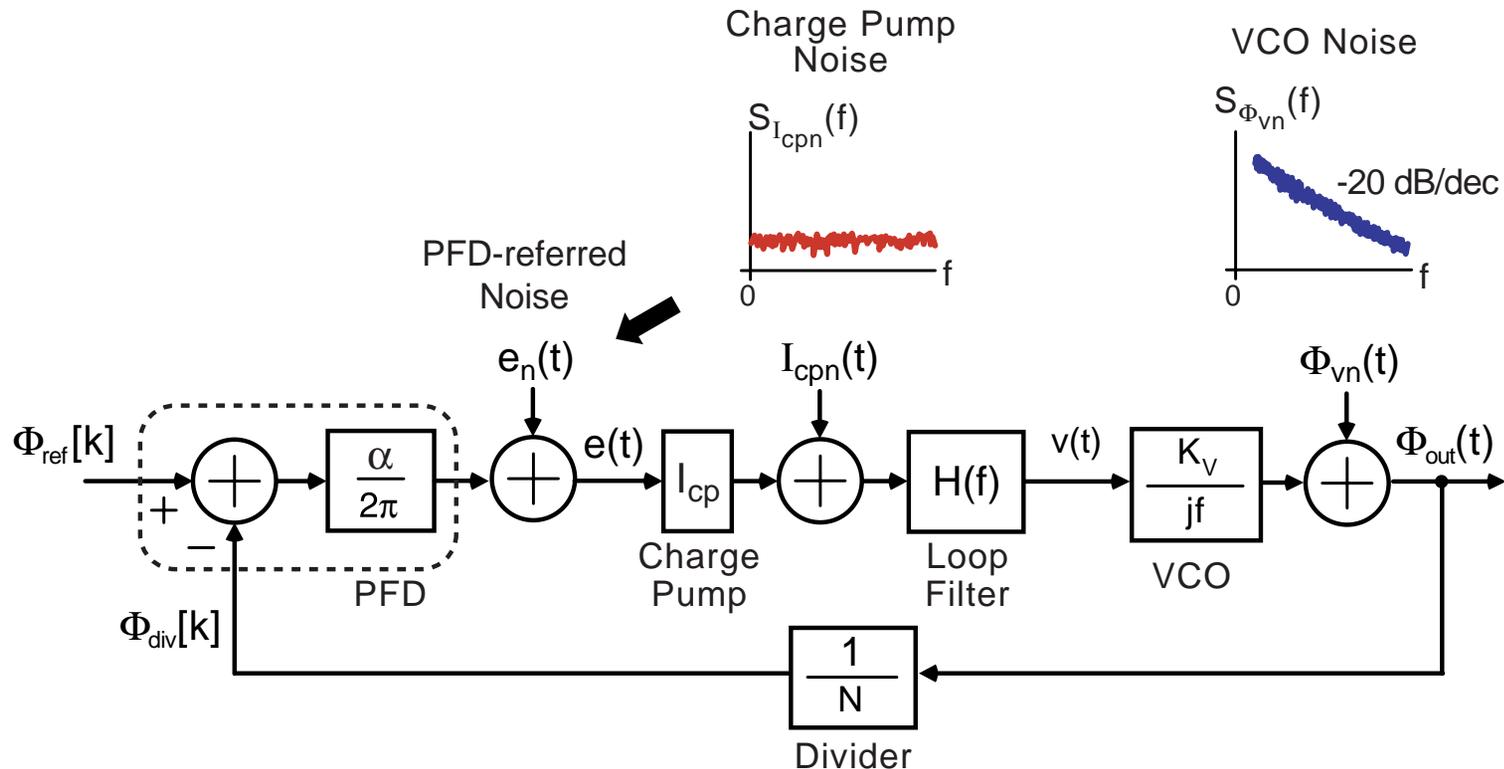
Analysis of Charge Pump Noise Impact



- We can refer charge pump noise to PFD output by simply scaling it by $1/I_{cp}$

$$\frac{\Phi_{out}}{I_{cpn}} = \left(\frac{1}{I_{cp}} \right) \frac{\Phi_{out}}{e_n} = \left(\frac{1}{I_{cp}} \right) \frac{2\pi}{\alpha} NG(f)$$

Calculation of Charge Pump Noise Impact

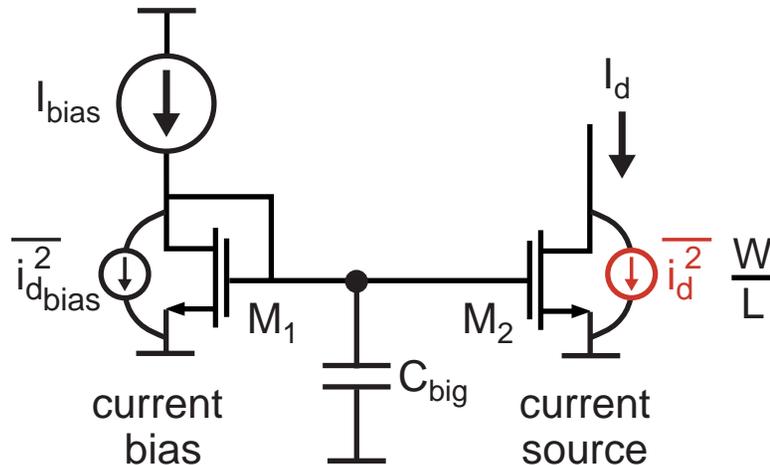


- **Contribution of charge pump noise to overall output noise**

$$S_{\Phi_{out}}(f) = \left(\frac{1}{I_{cp}}\right)^2 \left(\frac{2\pi N}{\alpha}\right)^2 |G(f)|^2 S_{I_{cpn}}(f) + \text{other sources}$$

- **Need to determine impact of I_{cp} on $S_{I_{cpn}}(f)$**

Impact of Transistor Current Value on its Noise



- Charge pump noise will be related to the current it creates as

$$S_{I_{cpn}}(f) \propto \frac{\overline{I_d^2}}{\Delta f} = 4kT\gamma g_{do}$$

- Recall that g_{do} is the channel resistance at zero V_{ds}
 - At a fixed current density, we have

$$g_{do} \propto W \propto I_d \Rightarrow \overline{I_d^2} \propto I_d$$

Impact of Charge Pump Current Value on Output Noise

- **Recall**

$$S_{\Phi_{out}}(f) = \left(\frac{1}{I_{cp}}\right)^2 \left(\frac{2\pi N}{\alpha}\right)^2 |G(f)|^2 S_{I_{cpn}}(f) + \text{other sources}$$

- **Given previous slide, we can say**

$$S_{I_{cpn}}(f) \propto I_{cp}$$

- Assumes a fixed current density for the key transistors in the charge pump as I_{cp} is varied

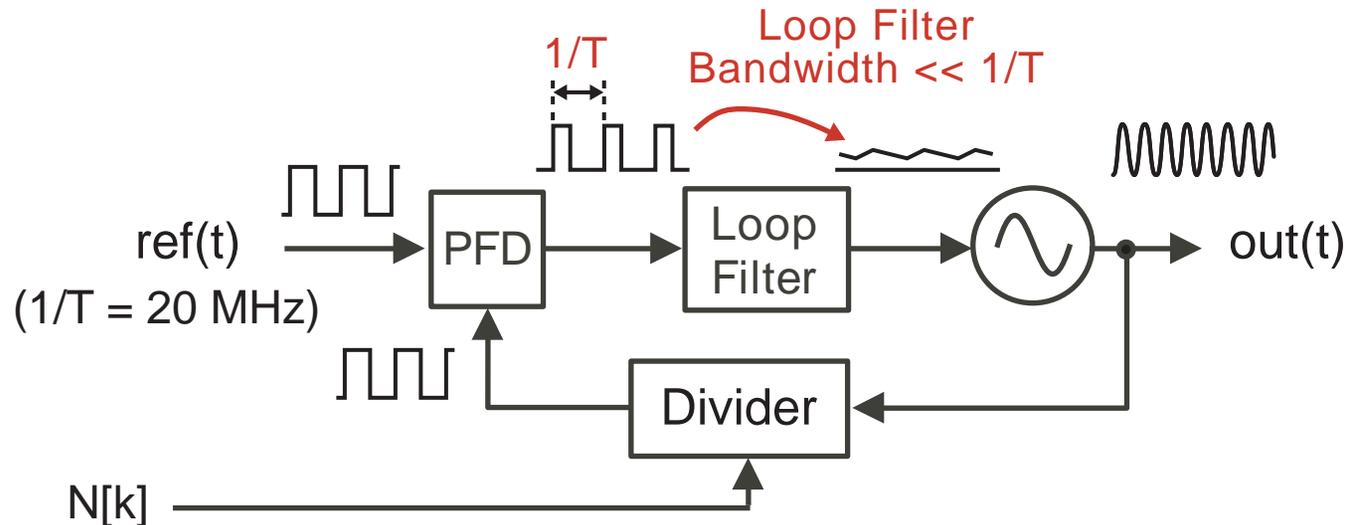
- **Therefore**

$$S_{\Phi_{out}}(f) \Big|_{\text{charge pump}} \propto \frac{1}{I_{cp}}$$

- Want high charge pump current to achieve low noise
- Limitation set by power and area considerations

Fractional-N Frequency Synthesizers

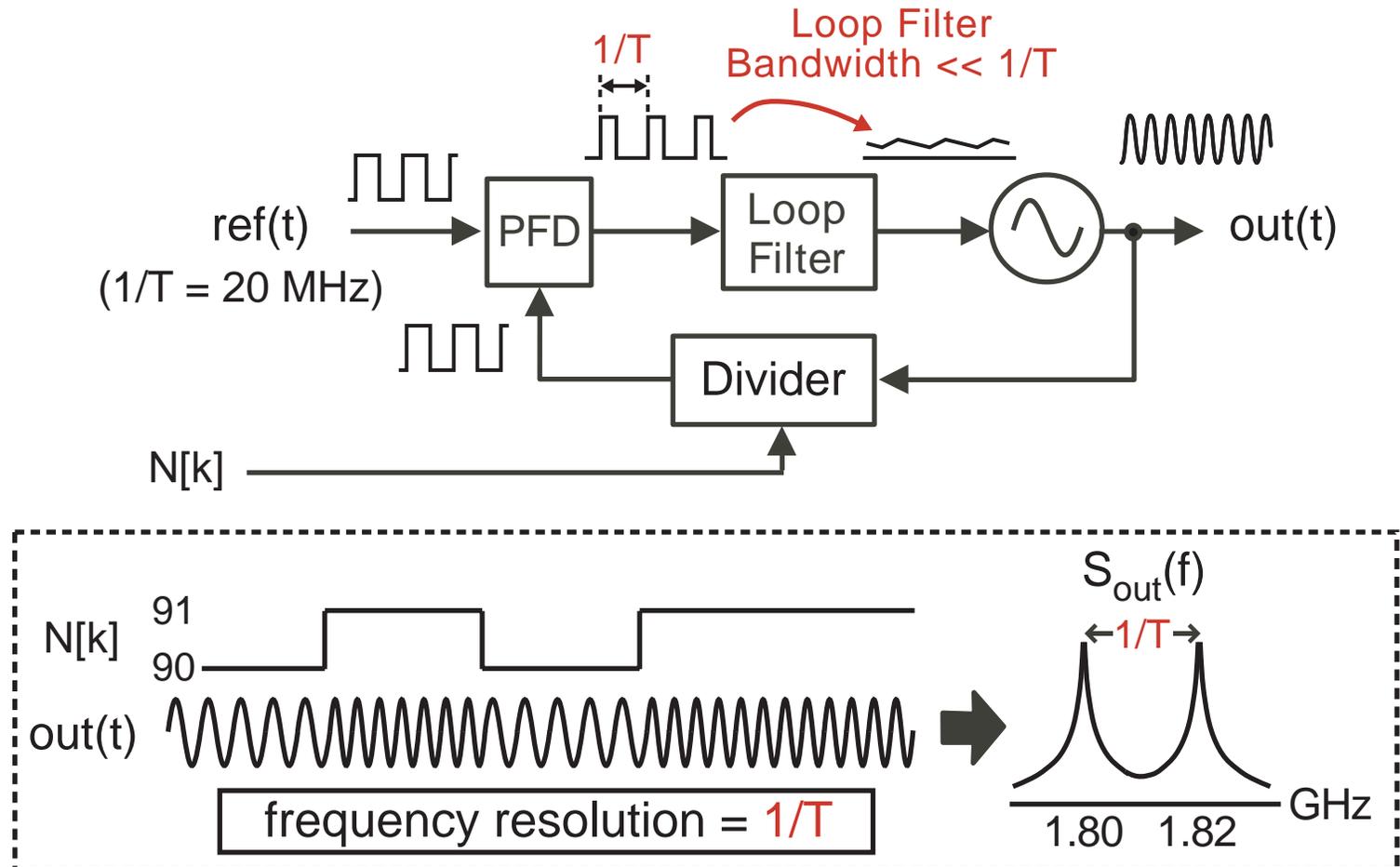
Bandwidth Constraints for Integer-N Synthesizers



- PFD output has a periodicity of $1/T$
 - $1/T =$ reference frequency
- Loop filter must have a bandwidth $\ll 1/T$
 - PFD output pulses must be filtered out and average value extracted

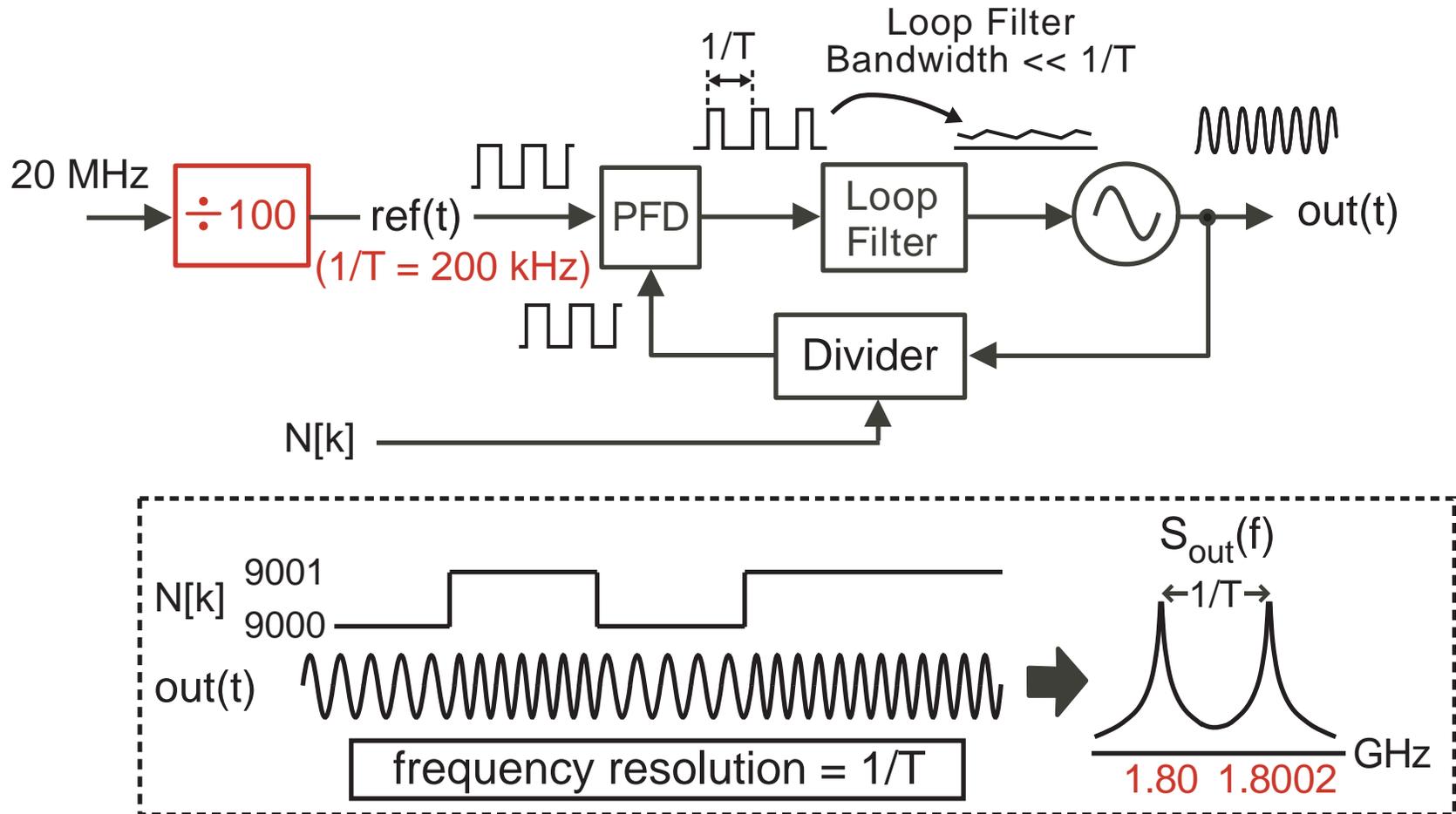
Closed loop PLL bandwidth often chosen to be a factor of ten lower than $1/T$

Bandwidth Versus Frequency Resolution



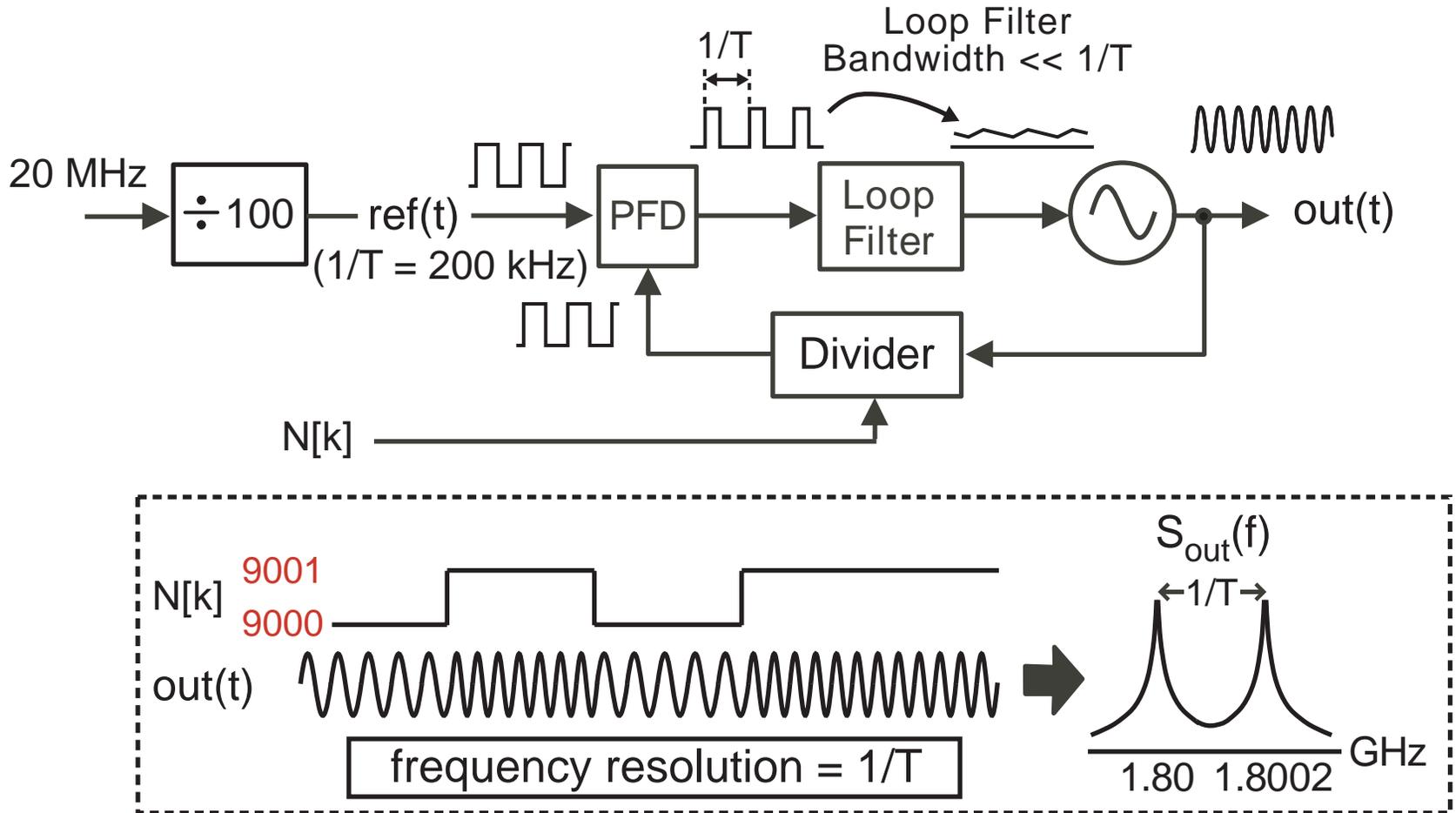
- Frequency resolution set by reference frequency ($1/T$)
 - Higher resolution achieved by lowering $1/T$

Increasing Resolution in Integer-N Synthesizers



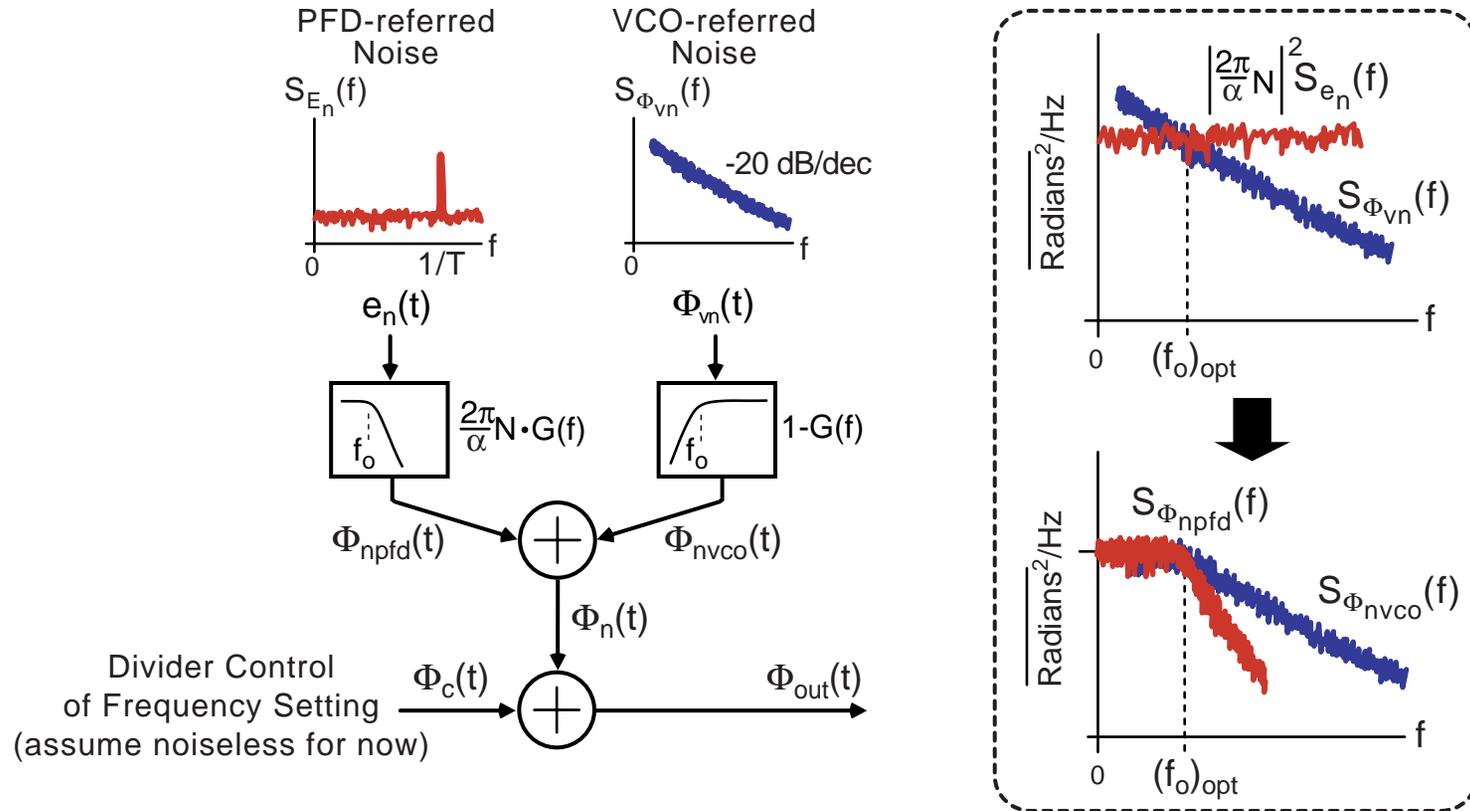
- Use a reference divider to achieve lower $1/T$
 - Leads to a low PLL bandwidth (< 20 kHz here)

The Issue of Noise



- Lower $1/T$ leads to higher divide value
 - Increases PFD noise at synthesizer output

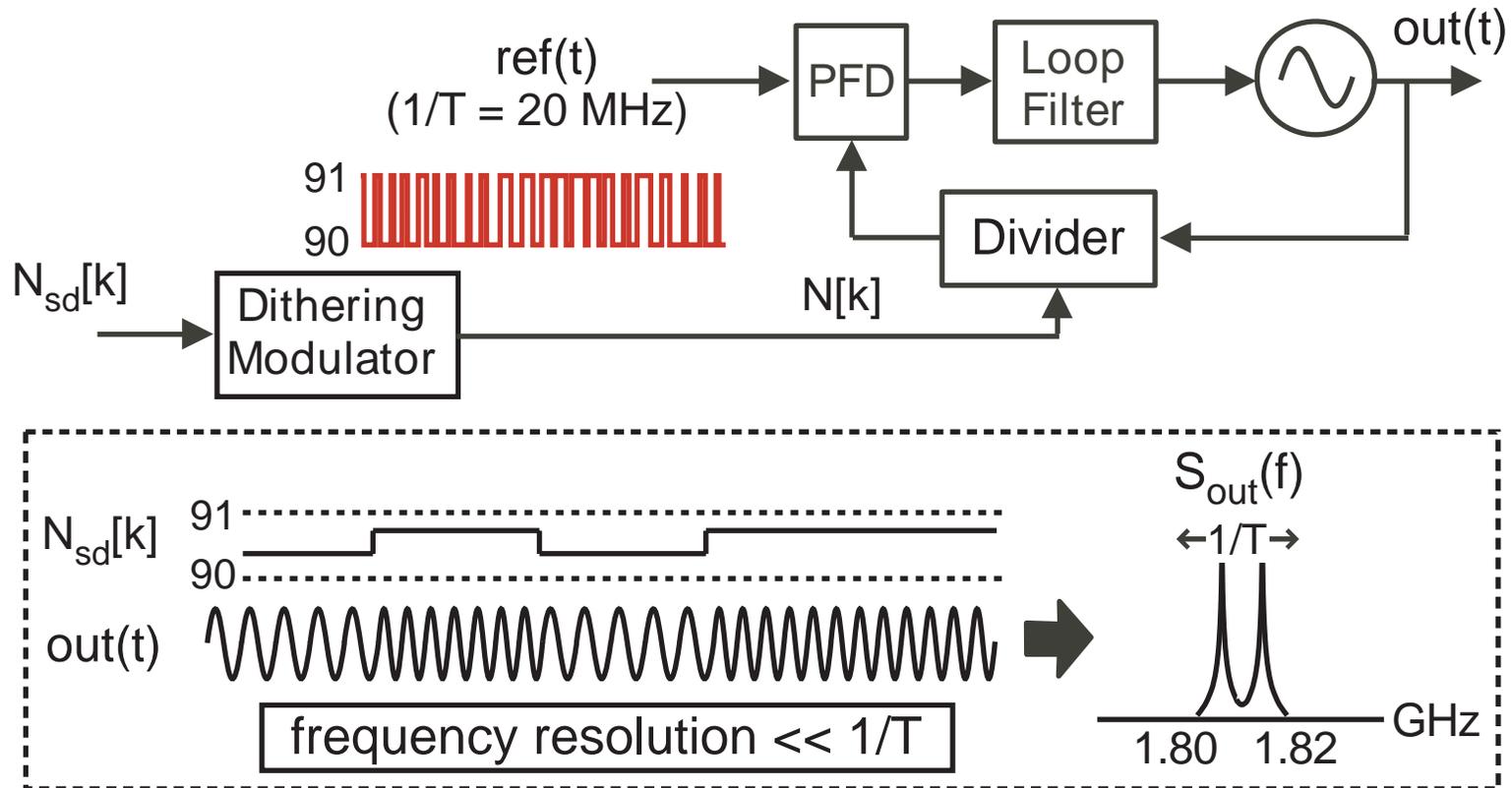
Modeling PFD Noise Multiplication



- **Influence of PFD noise seen in above model**
 - PFD spectral density multiplied by N^2 before influencing PLL output phase noise

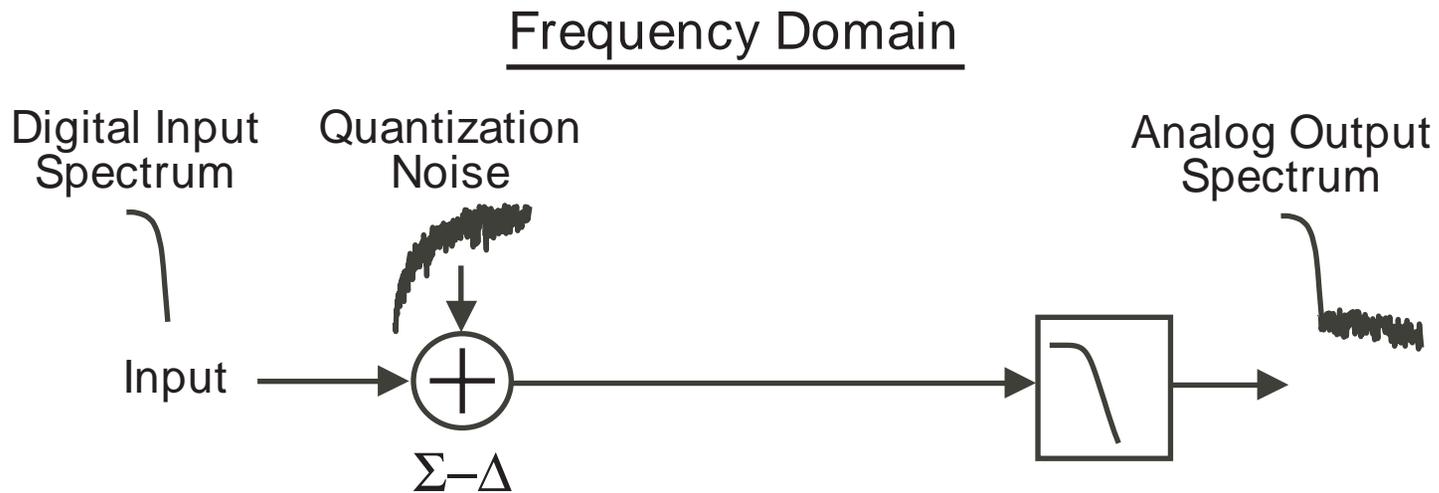
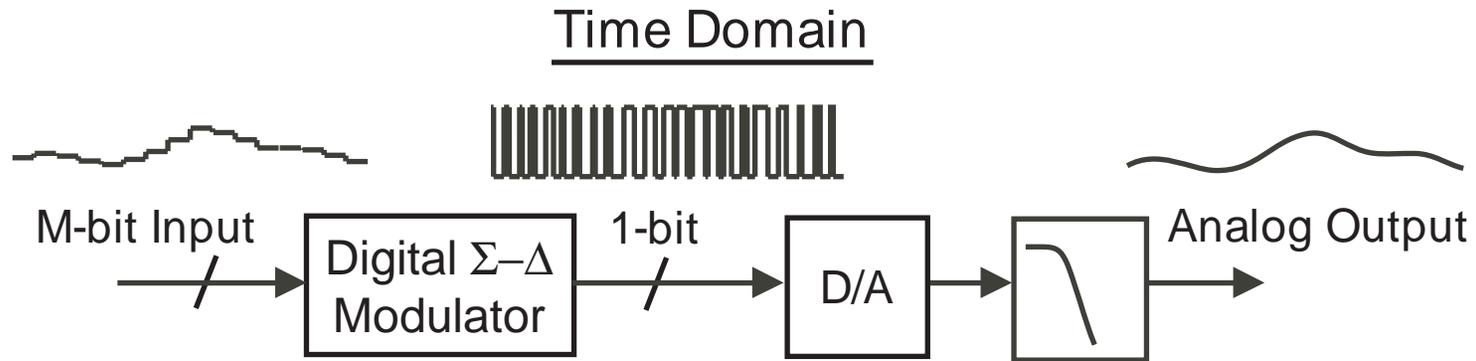
High divide values \rightarrow high phase noise at low frequencies

Fractional-N Frequency Synthesizers



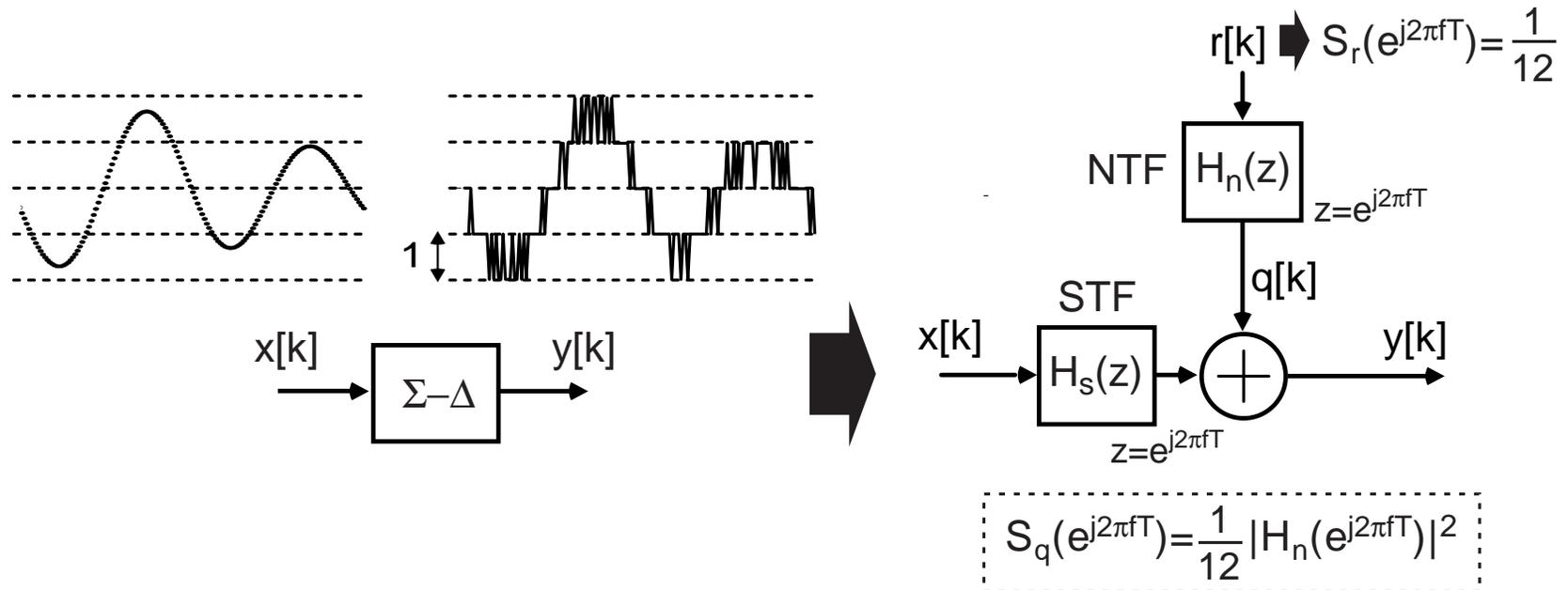
- **Break constraint that divide value be integer**
 - Dither divide value dynamically to achieve fractional values
 - Frequency resolution is now arbitrary regardless of $1/T$
- **Want high $1/T$ to allow a high PLL bandwidth**

A Nice Dithering Method: Sigma-Delta Modulation



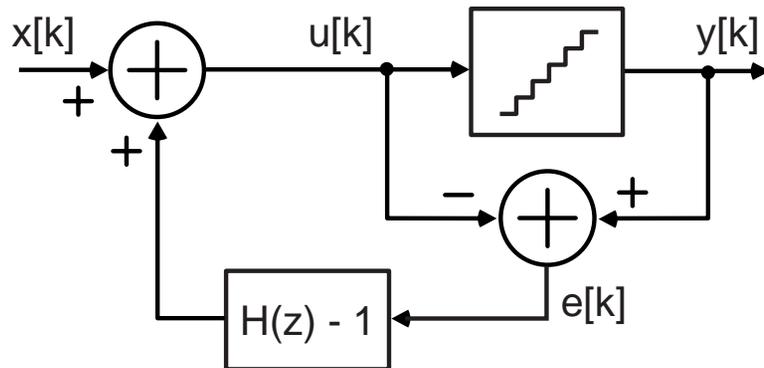
- **Sigma-Delta dithers in a manner such that resulting quantization noise is “shaped” to high frequencies**

Linearized Model of Sigma-Delta Modulator



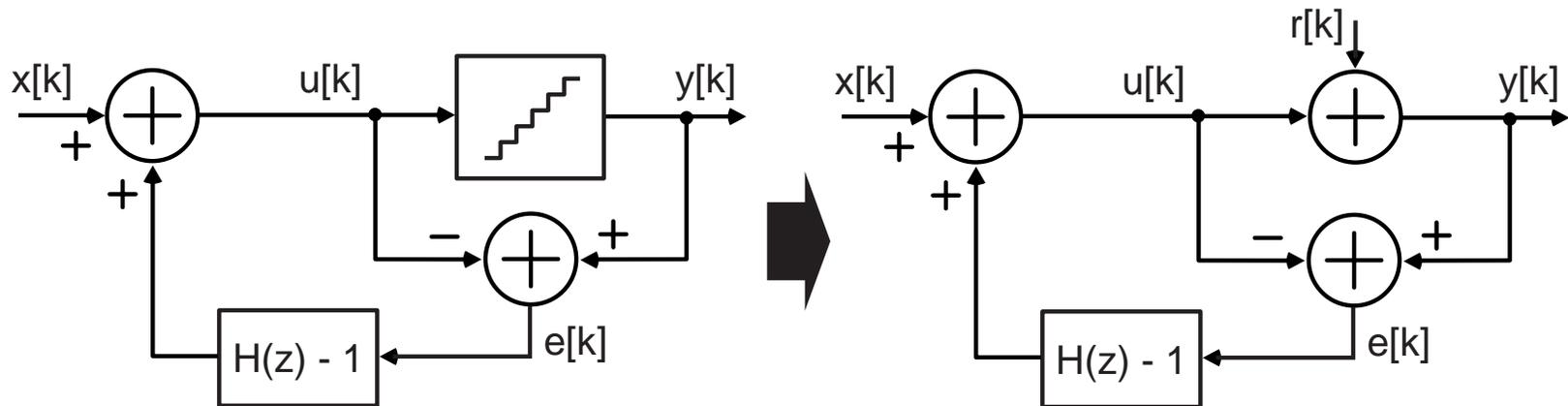
- **Composed of two transfer functions relating input and noise to output**
 - **Signal transfer function (STF)**
 - Filters input (generally undesirable)
 - **Noise transfer function (NTF)**
 - Filters (i.e., shapes) noise that is assumed to be white

Example: Cutler Sigma-Delta Topology



- **Output is quantized in a multi-level fashion**
- **Error signal, $e[k]$, represents the quantization error**
- **Filtered version of quantization error is fed back to input**
 - **$H(z)$ is typically a highpass filter whose first tap value is 1**
 - i.e., $H(z) = 1 + a_1 z^{-1} + a_2 z^{-2} \dots$
 - **$H(z) - 1$ therefore has a first tap value of 0**
 - Feedback needs to have delay to be realizable

Linearized Model of Cutler Topology



- Represent quantizer block as a summing junction in which $r[k]$ represents quantization error

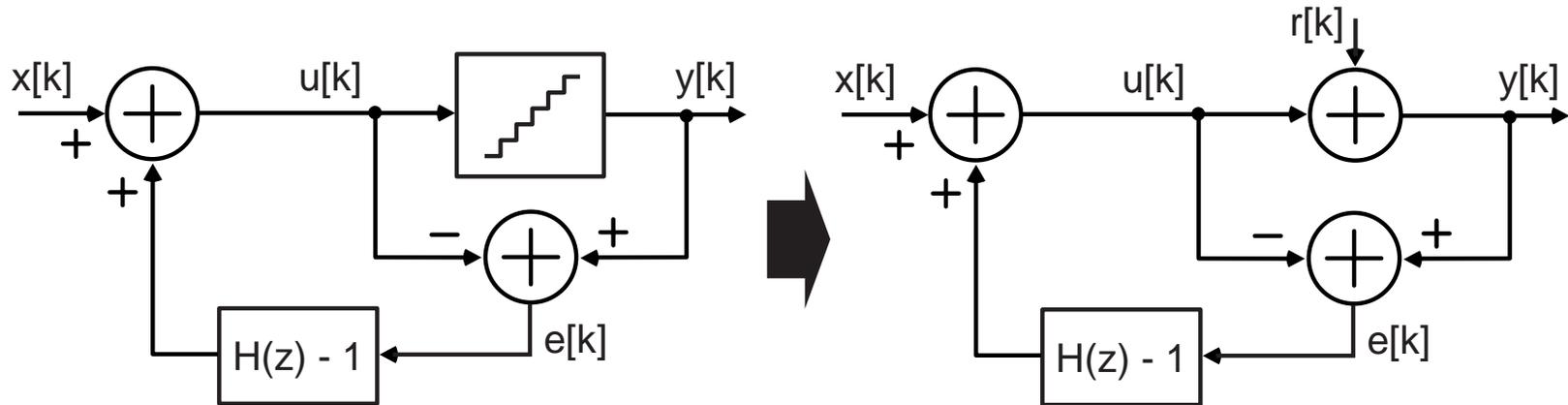
- Note:

$$e[k] = y[k] - u[k] = (u[k] + r[k]) - u[k] = r[k]$$

- It is assumed that $r[k]$ has statistics similar to white noise

- This is a key assumption for modeling – often not true!

Calculation of Signal and Noise Transfer Functions



- Calculate using Z-transform of signals in linearized model

$$Y(z) = U(z) + R(z)$$

$$= X(z) + (H(z) - 1)E(z) + R(z)$$

$$= X(z) + (H(z) - 1)R(z) + R(z)$$

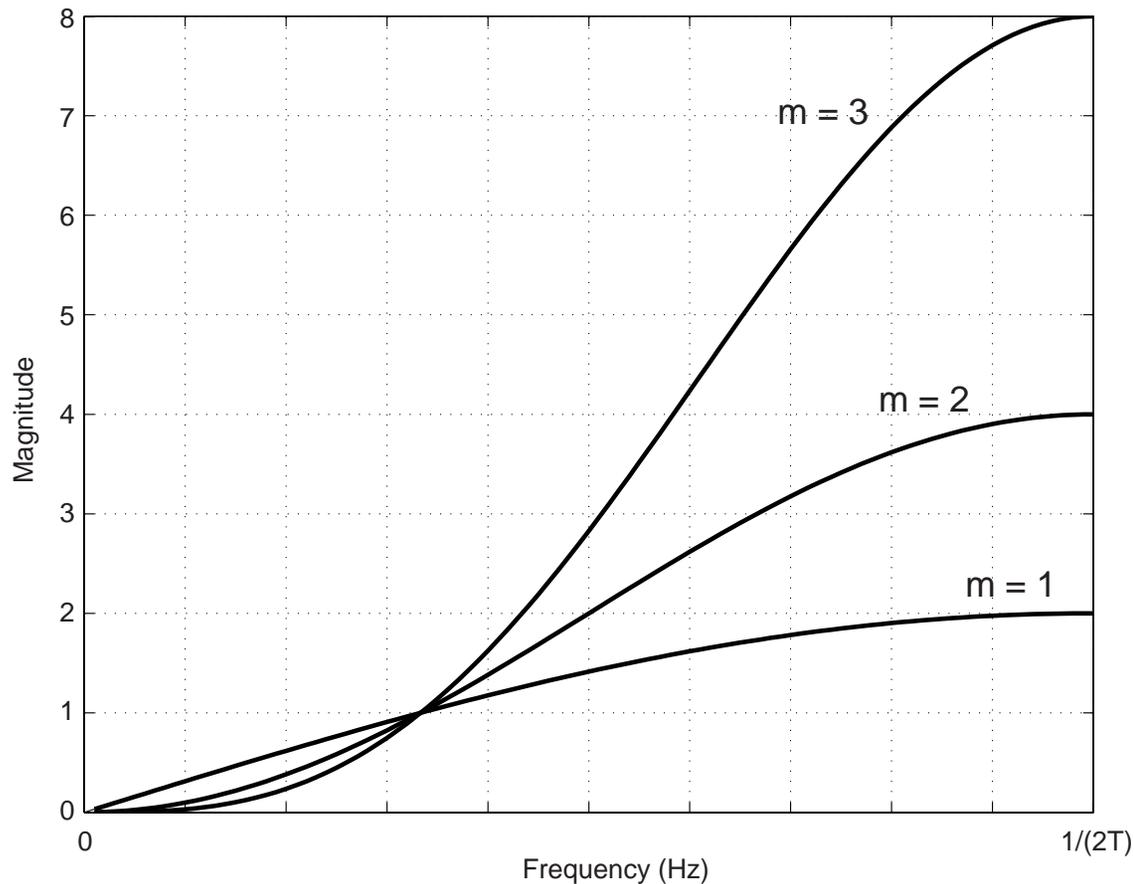
$$= X(z) + H(z)R(z)$$

- NTF: $H_n(z) = H(z)$

- STF: $H_s(z) = 1$

A Common Choice for $H(z)$

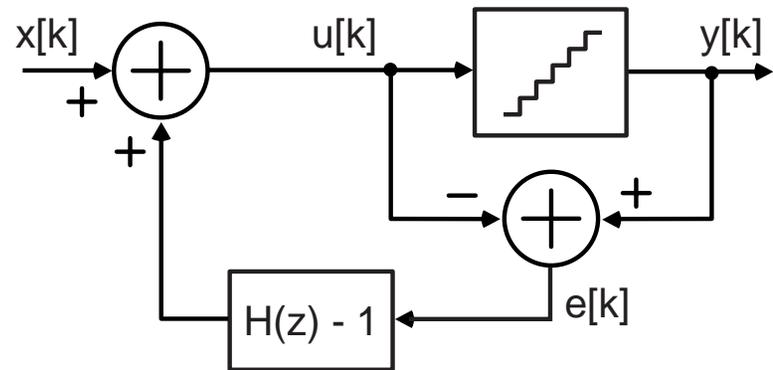
$$H(z) = (1 - z^{-1})^m$$
$$\Rightarrow |H(e^{j2\pi fT})| = |(1 - e^{-j2\pi fT})^m|$$



Example: First Order Sigma-Delta Modulator

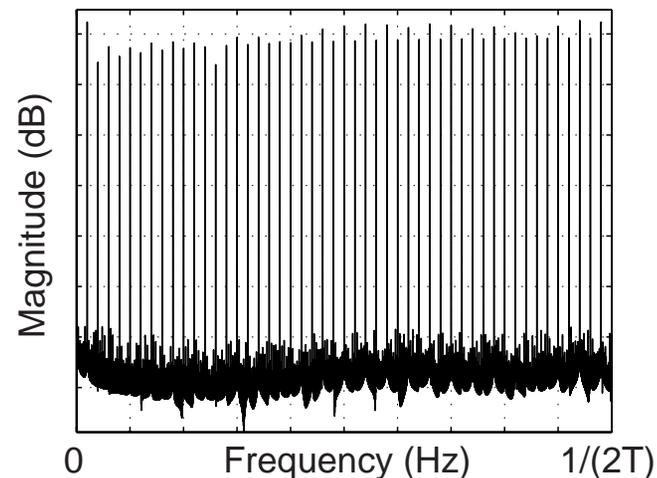
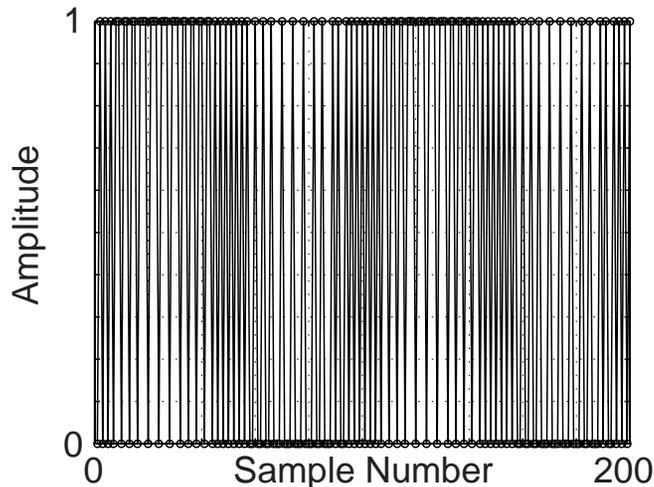
- Choose NTF to be

$$H_n(z) = H(z) = 1 - z^{-1}$$



- Plot of output in time and frequency domains with input of

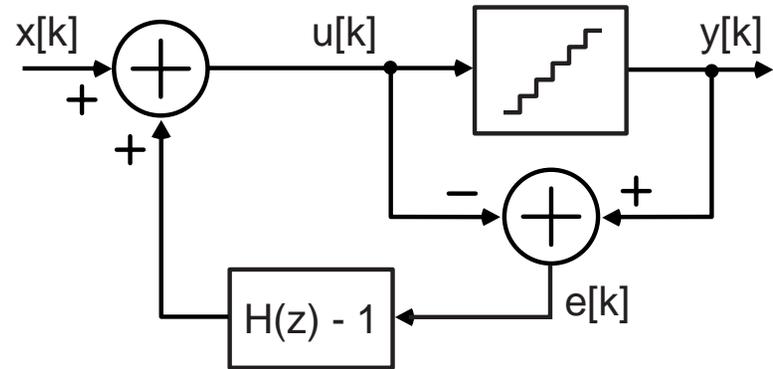
$$x[k] = 0.5 + 0.25 \sin\left(\frac{2\pi}{100}k\right)$$



Example: Second Order Sigma-Delta Modulator

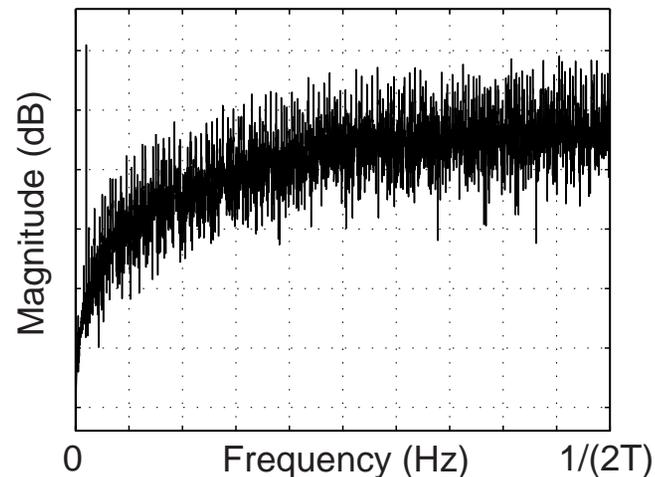
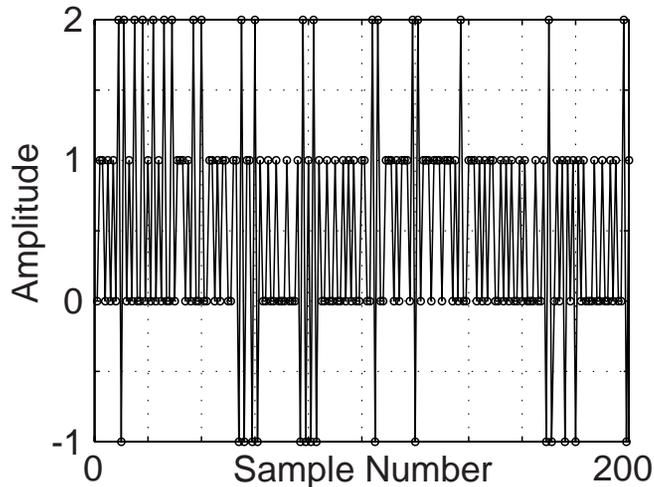
- Choose NTF to be

$$H_n(z) = H(z) = (1 - z^{-1})^2$$



- Plot of output in time and frequency domains with input of

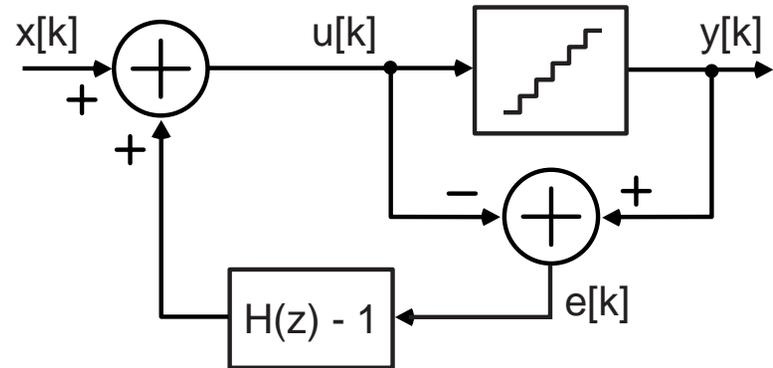
$$x[k] = 0.5 + 0.25 \sin\left(\frac{2\pi}{100}k\right)$$



Example: Third Order Sigma-Delta Modulator

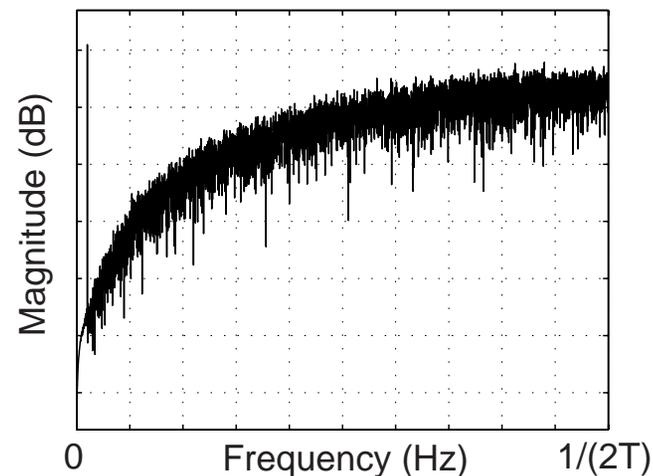
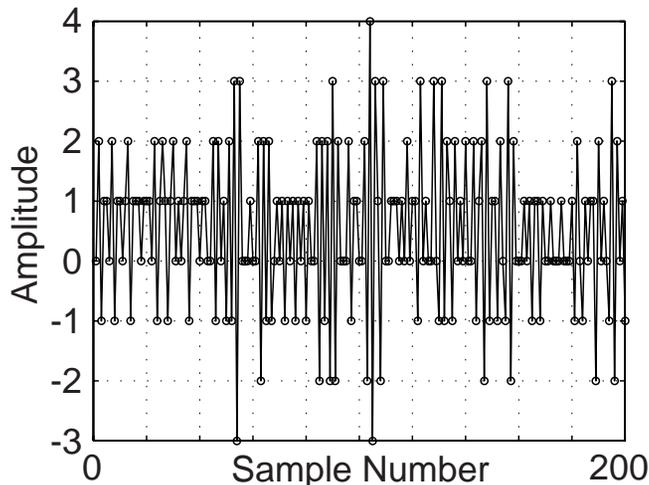
- Choose NTF to be

$$H_n(z) = H(z) = (1 - z^{-1})^3$$



- Plot of output in time and frequency domains with input of

$$x[k] = 0.5 + 0.25 \sin\left(\frac{2\pi}{100}k\right)$$

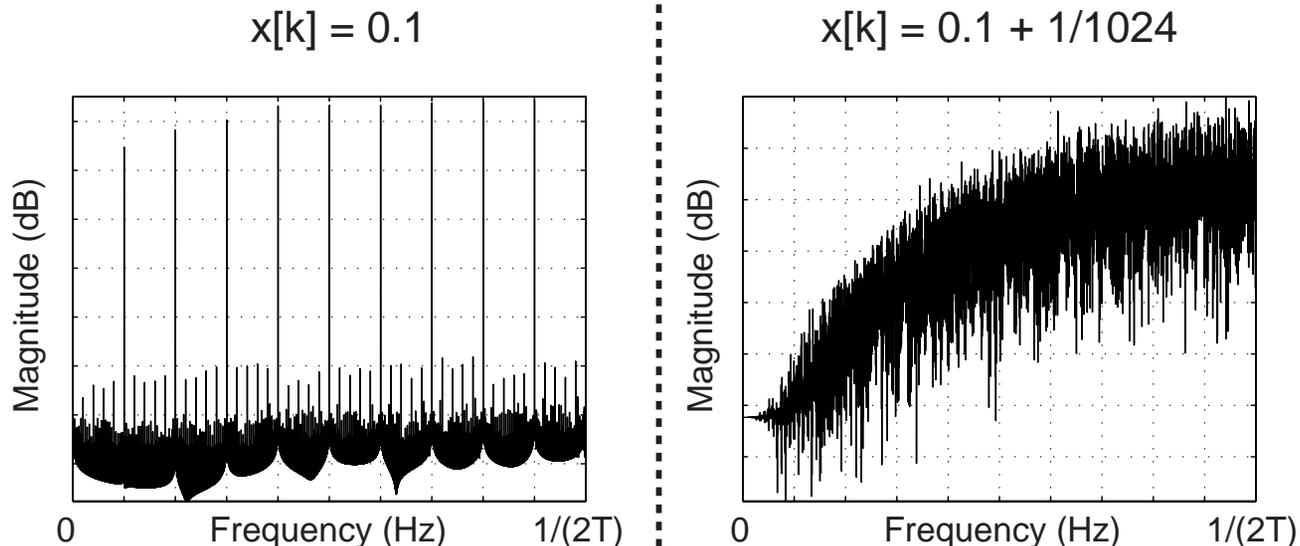


Observations

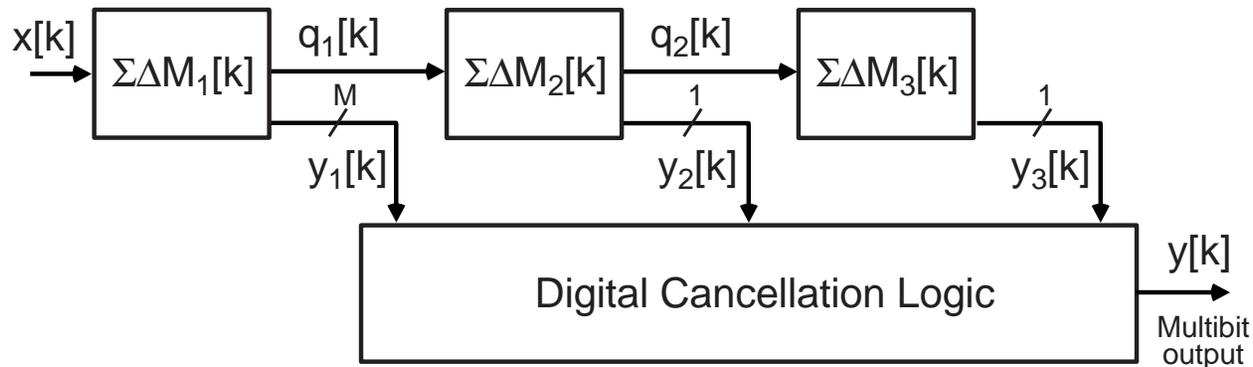
- **Low order Sigma-Delta modulators do not appear to produce “shaped” noise very well**
 - Reason: low order feedback does not properly “scramble” relationship between input and quantization noise
 - Quantization noise, $r[k]$, fails to be white
- **Higher order Sigma-Delta modulators provide much better noise shaping with fewer spurs**
 - Reason: higher order feedback filter provides a much more complex interaction between input and quantization noise

Warning: Higher Order Modulators May Still Have Tones

- Quantization noise, $r[k]$, is best whitened when a “sufficiently exciting” input is applied to the modulator
 - Varying input and high order helps to “scramble” interaction between input and quantization noise
- Worst input for tone generation are DC signals that are rational with a low valued denominator
 - Examples (third order modulator):

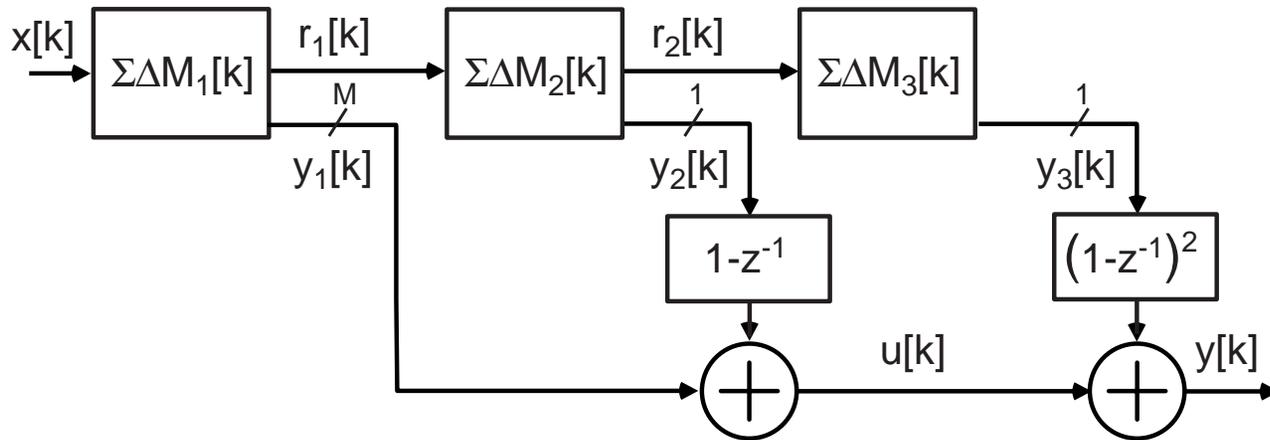


Cascaded Sigma-Delta Modulator Topologies



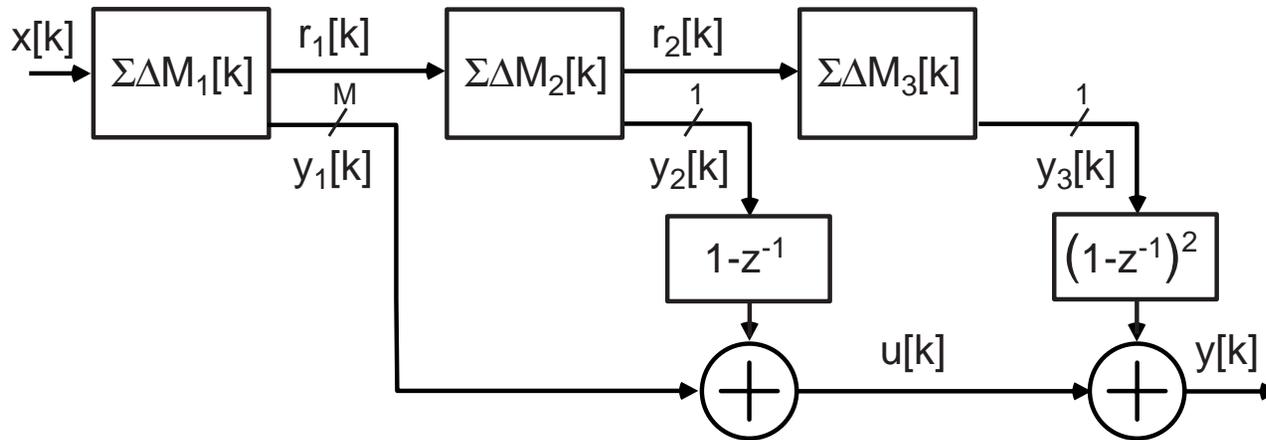
- Achieve higher order shaping by cascading low order sections and properly combining their outputs
- Advantage over single loop approach
 - Allows pipelining to be applied to implementation
 - High speed or low power applications benefit
- Disadvantages
 - Relies on precise matching requirements when combining outputs (not a problem for digital implementations)
 - Requires multi-bit quantizer (single loop does not)

MASH topology



- Cascade first order sections
- Combine their outputs after they have passed through digital differentiators

Calculation of STF and NTF for MASH topology (Step 1)



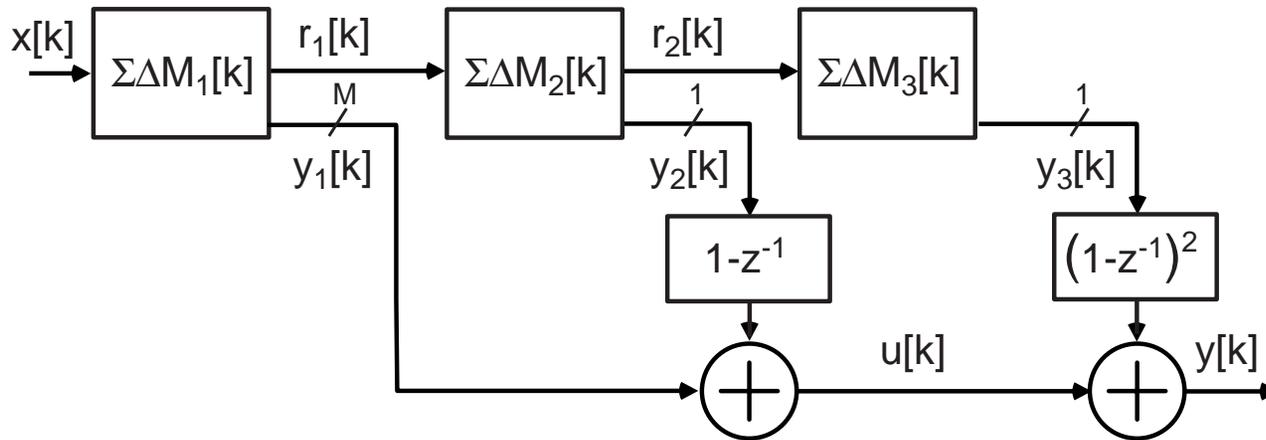
Individual output signals of each first order modulator

$$\begin{aligned}
 y_1(z) &= x(z) - (1 - z^{-1})r_1(z) \\
 y_2(z) &= r_1(z) - (1 - z^{-1})r_2(z) \\
 y_3(z) &= r_2(z) - (1 - z^{-1})r_3(z)
 \end{aligned}$$

Addition of filtered outputs

$$\begin{aligned}
 & y_1(z) \\
 + & (1 - z^{-1})y_2(z) \\
 + & (1 - z^{-1})^2 y_2(z) \\
 \hline
 = & x(z) - (1 - z^{-1})^3 r_3(z)
 \end{aligned}$$

Calculation of STF and NTF for MASH topology (Step 1)

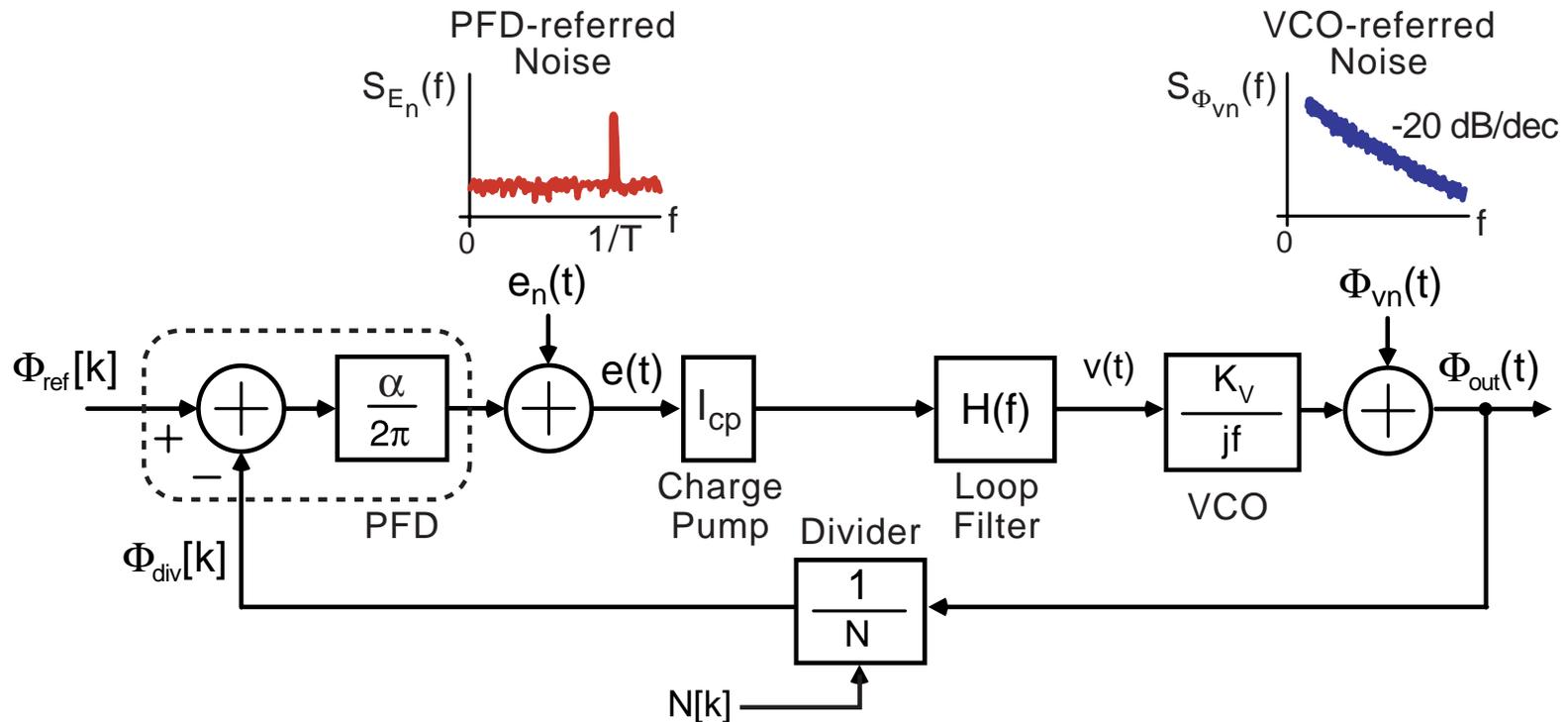


Overall modulator behavior

$$y(z) = x(z) - (1 - z^{-1})^3 r_3(z)$$

- STF: $H_s(z) = 1$
- NTF: $H_n(z) = (1 - z^{-1})^3$

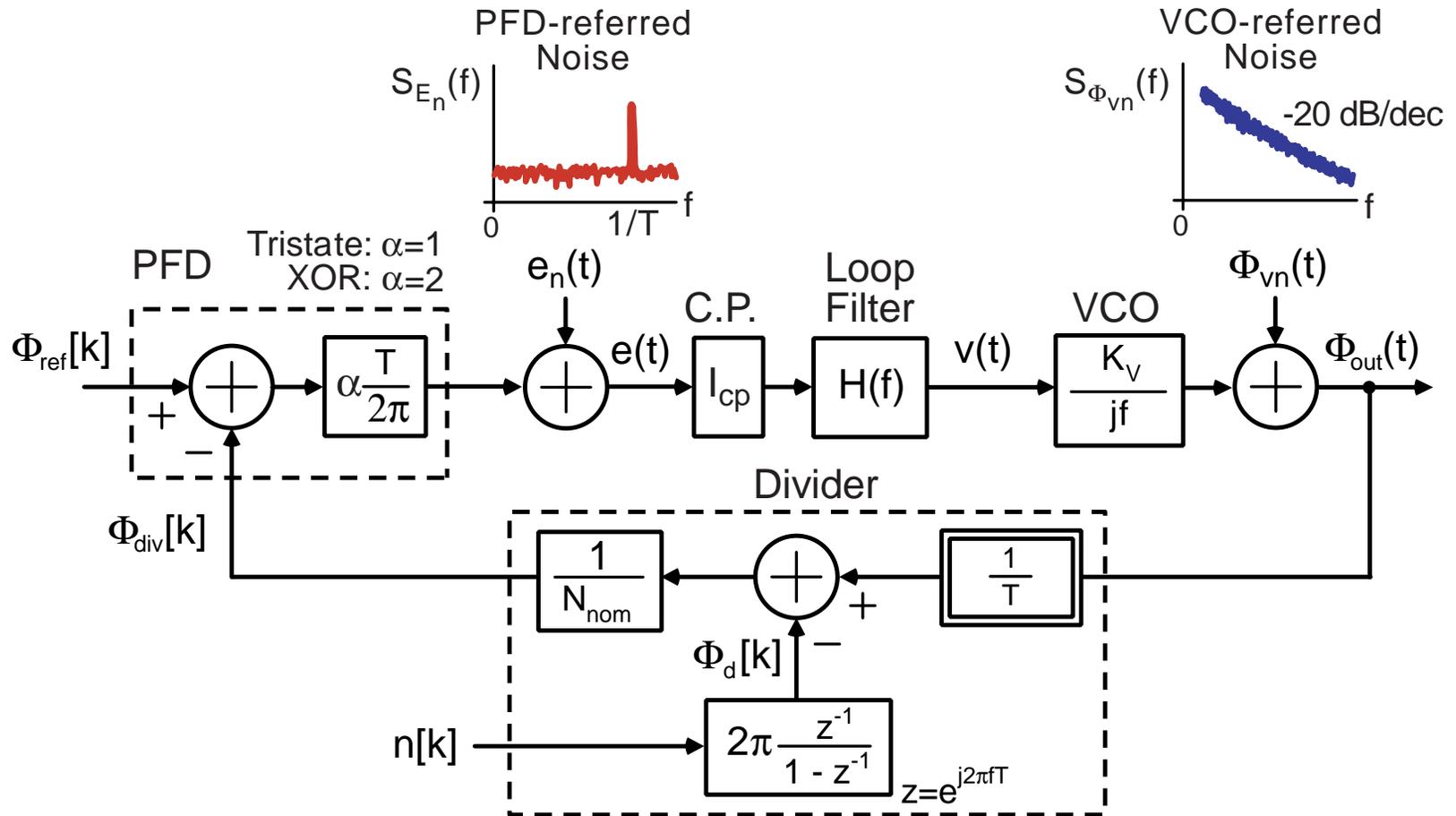
Background: The Need for A Better PLL Model



■ Classical PLL model

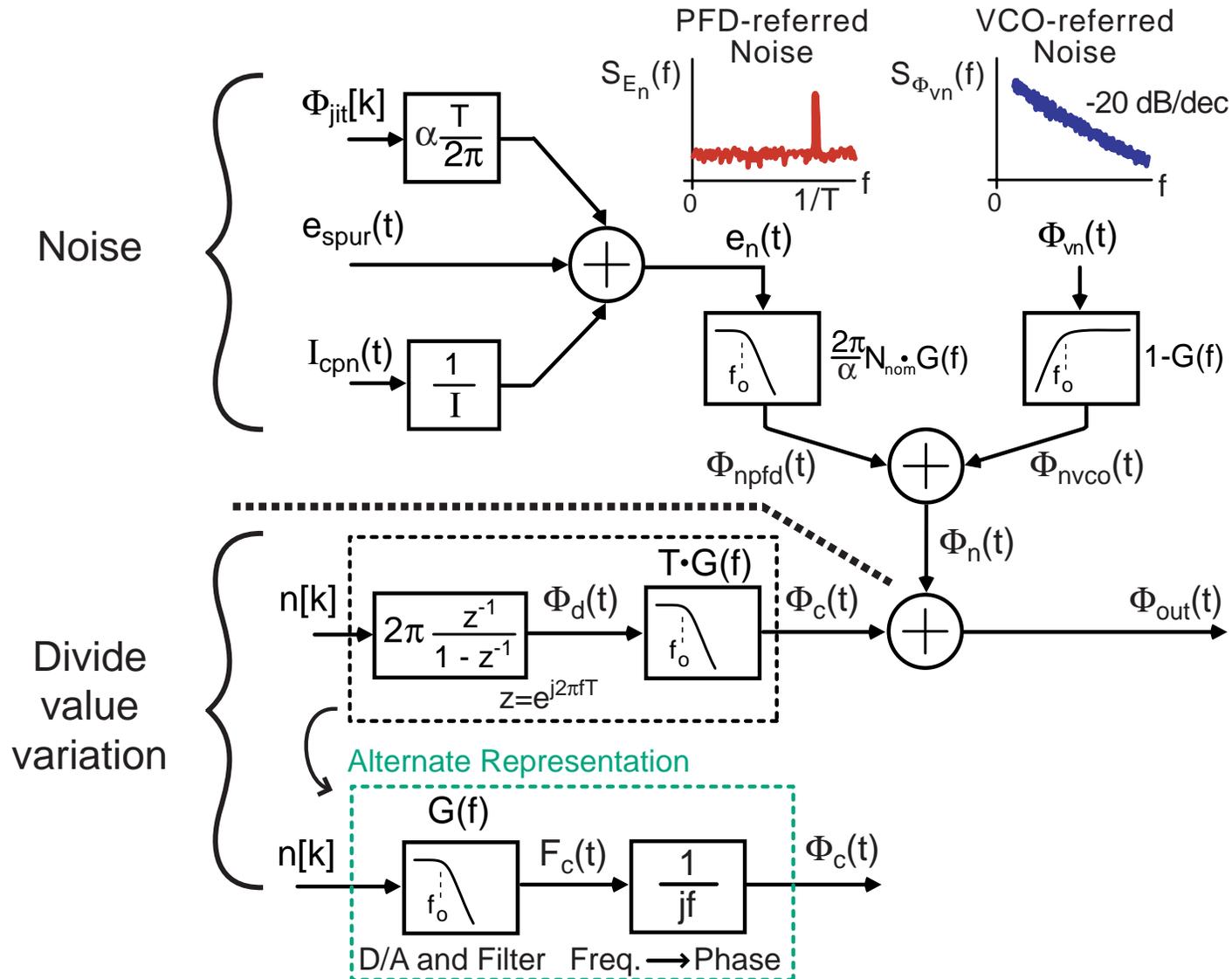
- Predicts impact of PFD and VCO referred noise sources
- Does not allow straightforward modeling of impact due to divide value variations
 - This is a problem when using fractional-N approach

A PLL Model Accommodating Divide Value Variations



- See derivation in Perrott et. al., "A Modeling Approach for Sigma-Delta Fractional-N Frequency Synthesizers ...", JSSC, Aug 2002

Parameterized Version of New Model

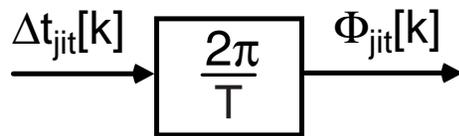
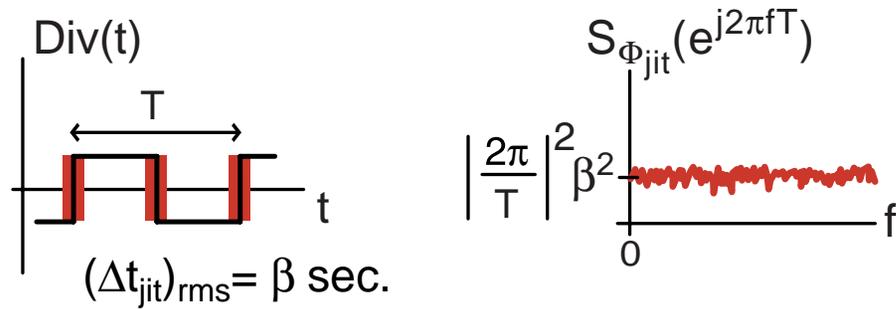


Spectral Density Calculations



- **Case (a):** $S_y(f) = |H(f)|^2 S_x(f)$
- **Case (b):** $S_y(e^{j2\pi fT}) = |H(e^{j2\pi fT})|^2 S_x(e^{j2\pi fT})$
- **Case (c):** $S_y(f) = \frac{1}{T} |H(f)|^2 S_x(e^{j2\pi fT})$

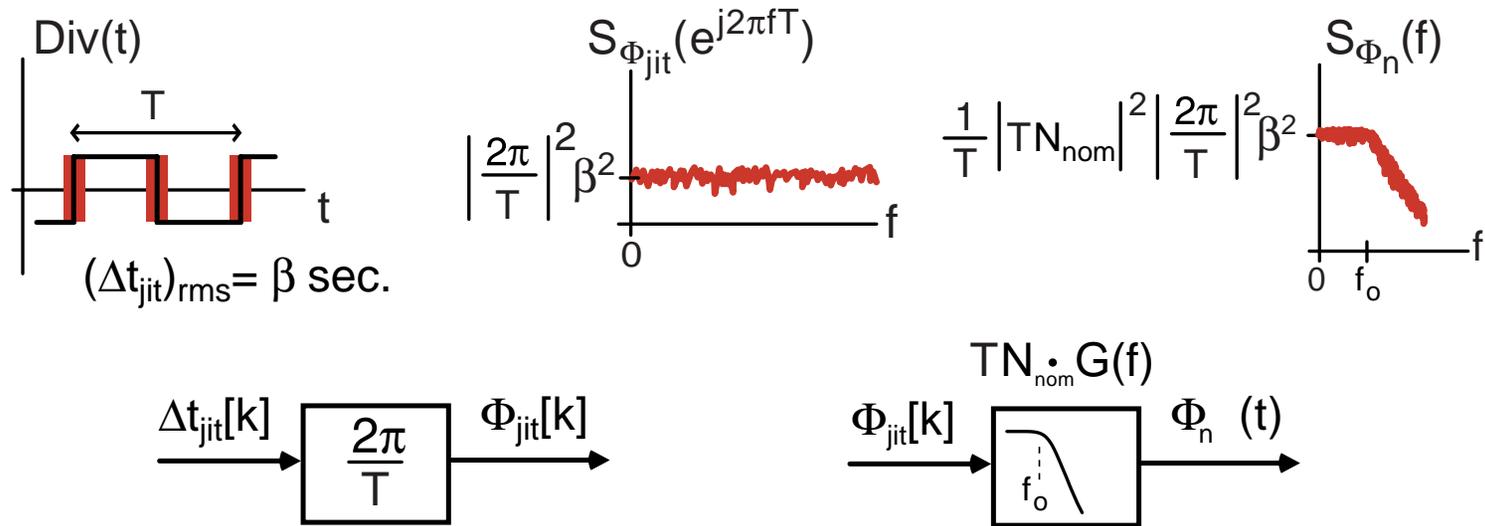
Example: Calculate Impact of Ref/Divider Jitter (Step 1)



- Assume jitter is white
 - i.e., each jitter value independent of values at other time instants
- Calculate spectra for discrete-time input and output
 - Apply case (b) calculation

$$S_{\Delta t_{jit}}(e^{j2\pi fT}) = \beta^2 \Rightarrow S_{\Phi_{jit}}(e^{j2\pi fT}) = \left|\frac{2\pi}{T}\right|^2 \beta^2$$

Example: Calculate Impact of Ref/Divider Jitter (Step 2)

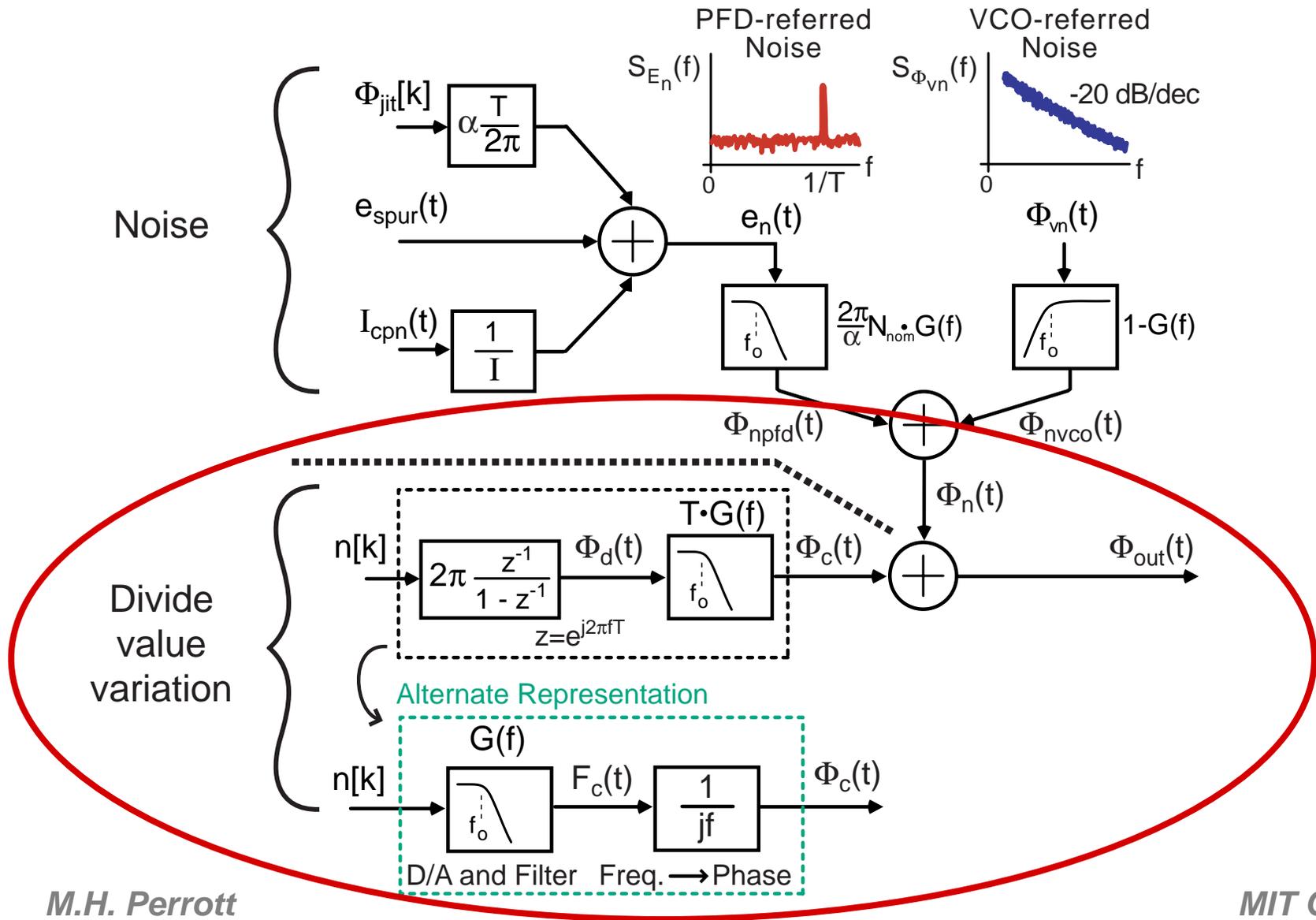


- **Compute impact on output phase noise of synthesizer**
 - We now apply case (c) calculation

$$\begin{aligned}
 S_{\Phi_n}(f) &= \frac{1}{T} |TN_{nom} G(f)|^2 S_{\Phi_{jit}}(e^{j2\pi fT}) \\
 &= \frac{1}{T} |TN_{nom} G(f)|^2 \left|\frac{2\pi}{T}\right|^2 \beta^2
 \end{aligned}$$

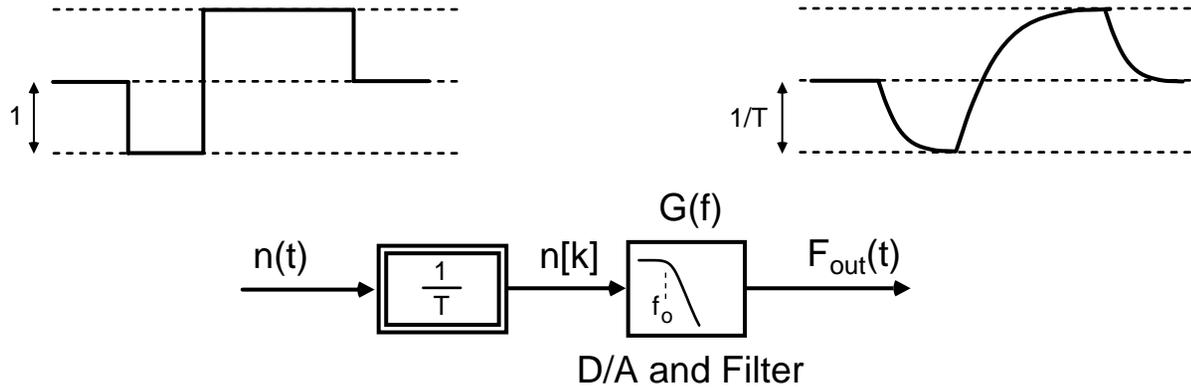
- Note that $G(f) = 1$ at DC

Now Consider Impact of Divide Value Variations

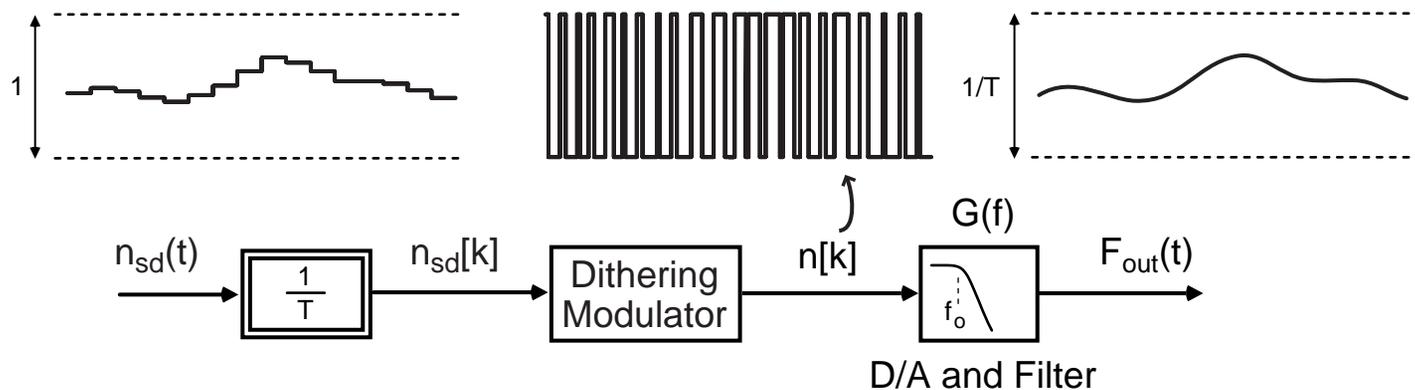


Divider Impact For Classical Vs Fractional-N Approaches

Classical Synthesizer

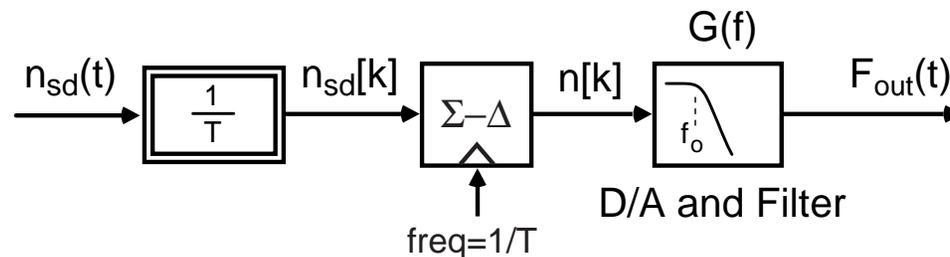
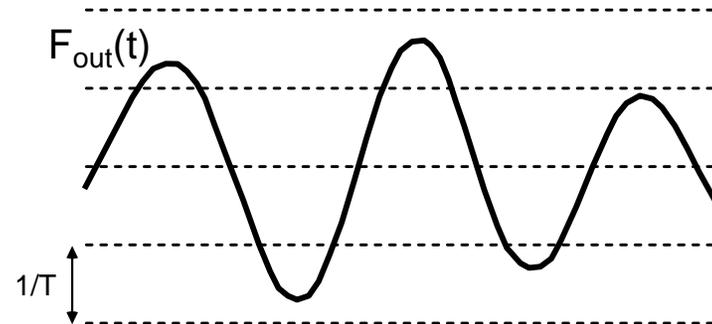
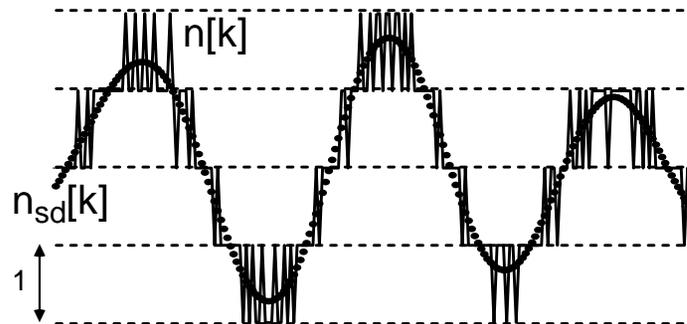


Fractional-N Synthesizer



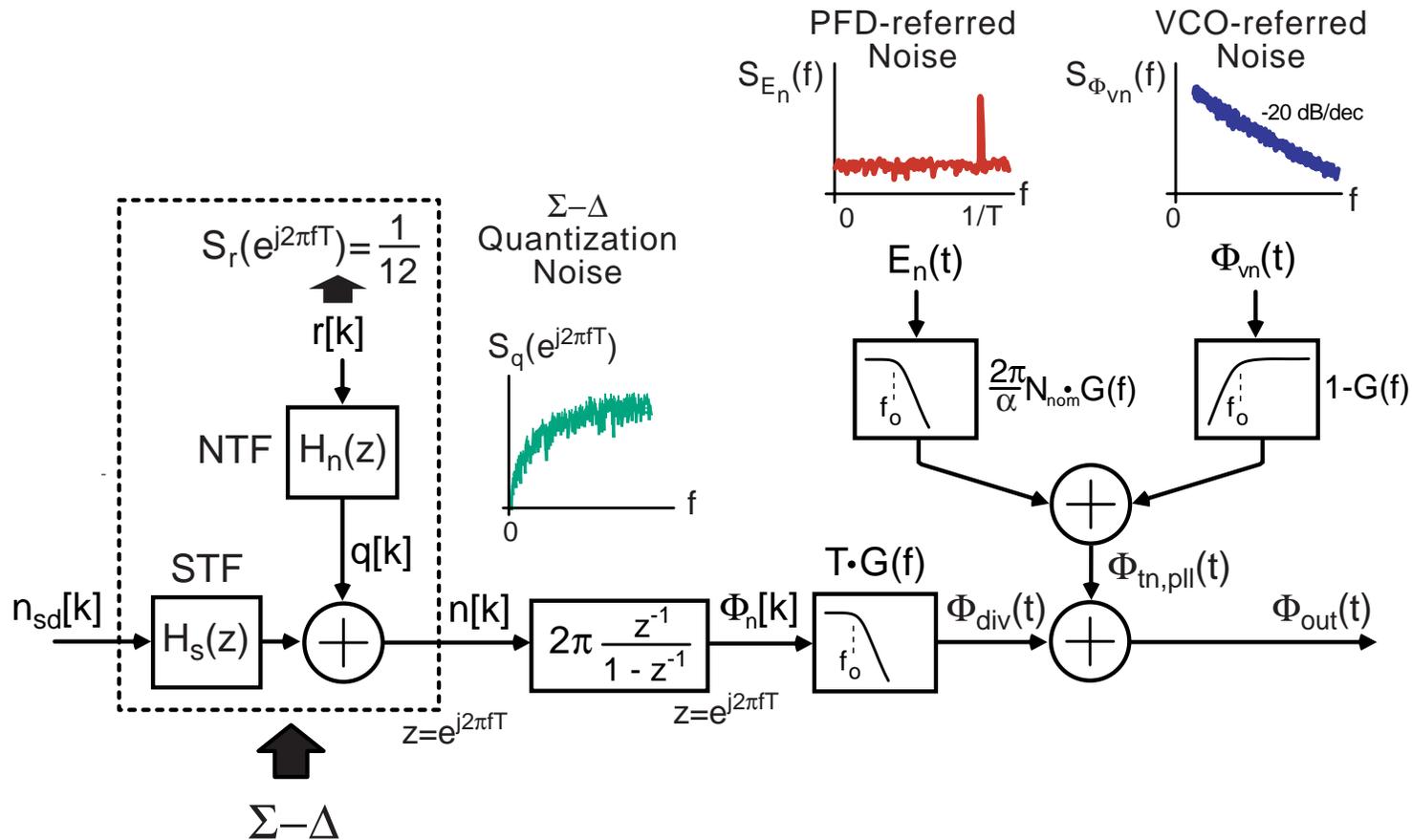
■ **Note:** $1/T$ block represents sampler (to go from CT to DT)

Focus on Sigma-Delta Frequency Synthesizer



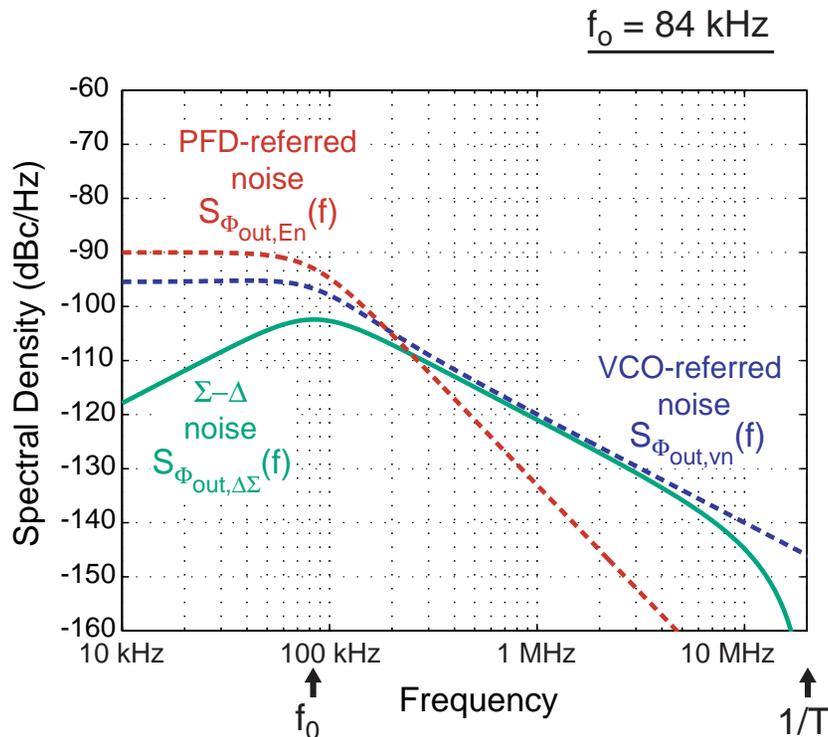
- Divide value can take on fractional values
 - Virtually arbitrary resolution is possible
- PLL dynamics act like lowpass filter to remove much of the quantization noise

Quantifying the Quantization Noise Impact



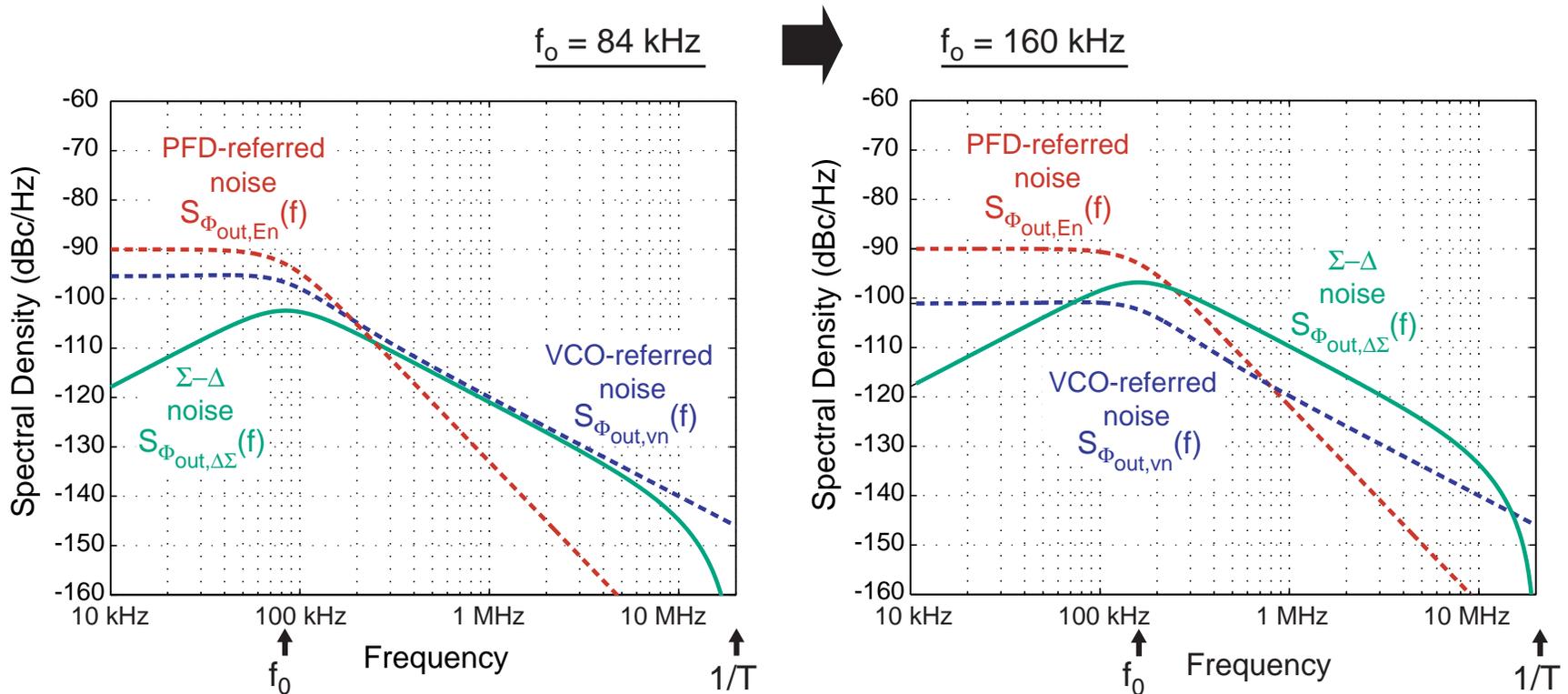
- Calculate by simply attaching Sigma-Delta model
 - We see that quantization noise is integrated and then lowpass filtered before impacting PLL output

A Well Designed Sigma-Delta Synthesizer



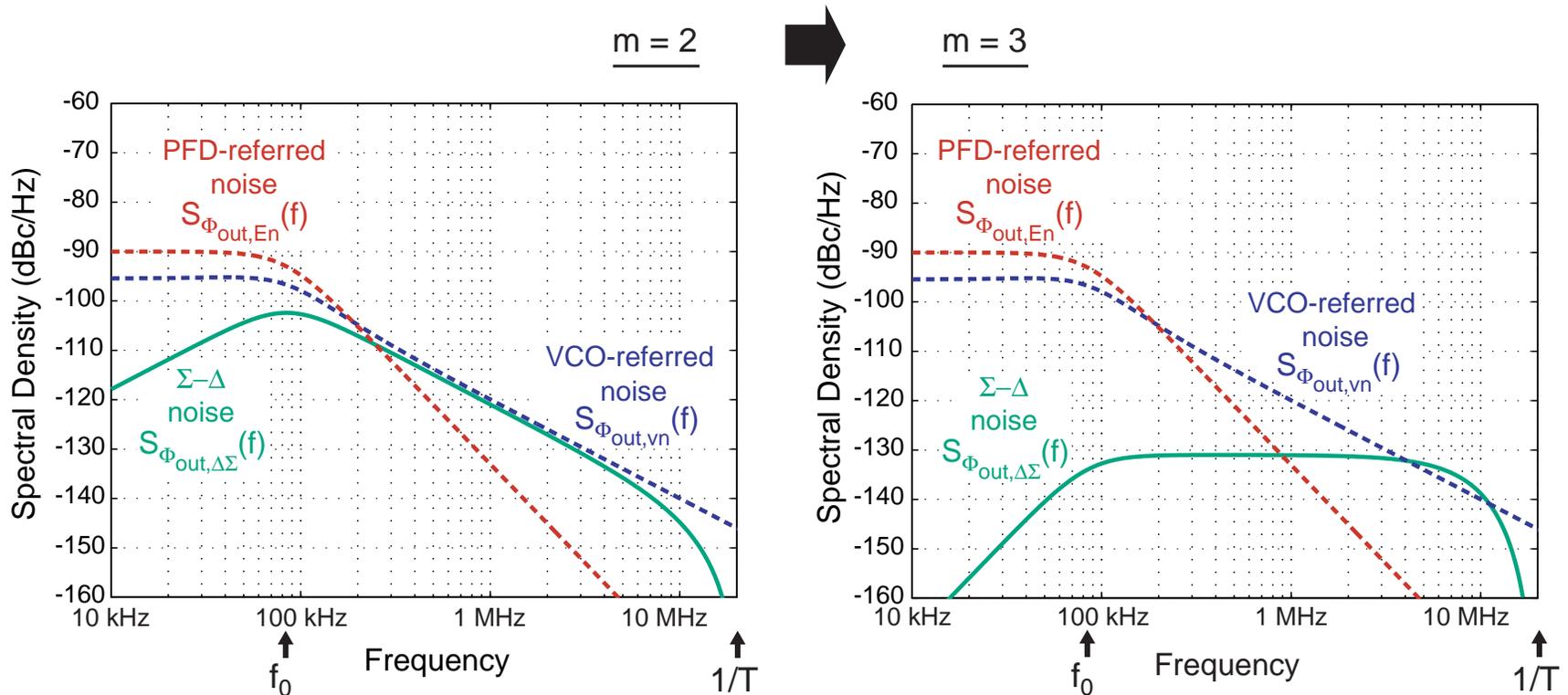
- Order of $G(f)$ is set to equal to the Sigma-Delta order
 - Sigma-Delta noise falls at -20 dB/dec above $G(f)$ bandwidth
- Bandwidth of $G(f)$ is set low enough such that synthesizer noise is dominated by intrinsic PFD and VCO noise

Impact of Increased PLL Bandwidth



- Allows more PFD noise to pass through
- Allows more Sigma-Delta noise to pass through
- Increases suppression of VCO noise

Impact of Increased Sigma-Delta Order



- PFD and VCO noise unaffected
- Sigma-Delta noise no longer attenuated by $G(f)$ such that a -20 dB/dec slope is achieved above its bandwidth